

Recent Advances in Anisotropic Conductive Films (ACFs) Technology for Wearable Electronics

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San Jose, CA USA**

1. Wearable Market trends

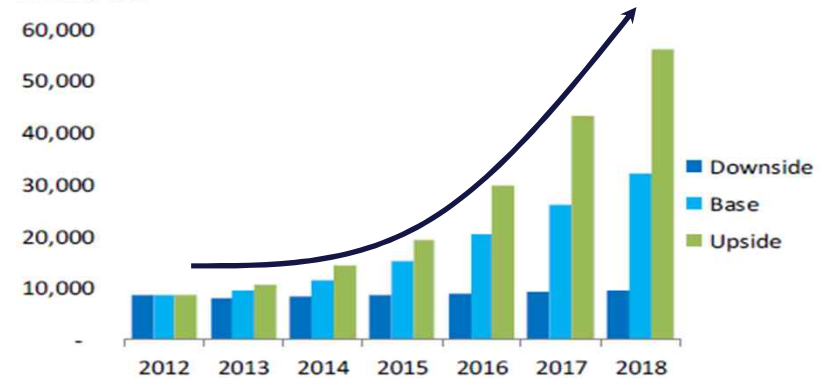
Wearable device in movies



Now, start wearable device war

Preliminary Scenario Forecast - Wearable Technology

Millions \$US



Source: IHS Inc. September 2013



IHS Electronics & Media

Source: IHS World Market for Wearable Technology - 2012, 2013



Wearable electronics trends

Convergence to Smart Phone



Divergence to wearable device



➤ **Wearable devices perform subsidiary functions of smart phone by using wireless network.**

Trends in wearable electronic devices

Ref)

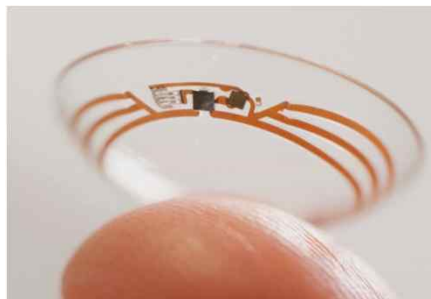
Google glass : <https://www.google.com/glass/start/>
Smart contact lens : <http://googleblog.blogspot.kr/2014/01/introducing-our-smart-contact-lens.html>

Galaxy gear : <http://www.samsung.com/us/mobile/wearable-tech/SM-V7000ZKAXAR>

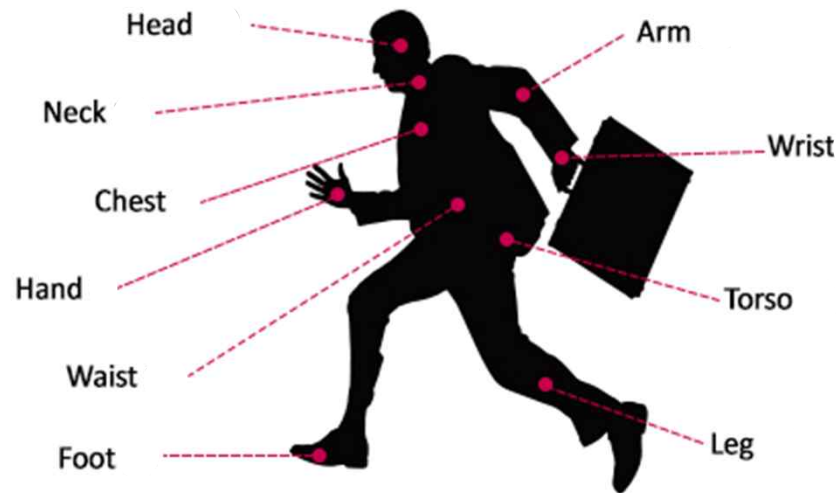
MC10 sensor : <http://www.mc10inc.com/>



<Google glass>



<smart contact lens>

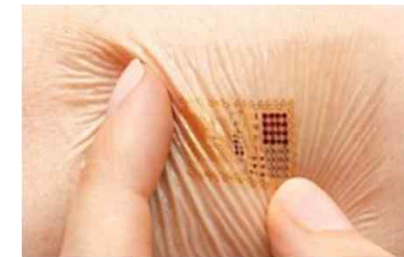


wearable devices for each body parts

- ✓ **Miniaturization**
- ✓ **Light weight**
- ✓ **Flexibility**
- ✓ **Reliability**
- ✓ **High performance**



<Galaxy gear>



<MC10 sensor>

Trends in wearable electronic devices

Source) Nike



Nike-google fuel band

***Flexible package is necessary
for wearable electronic devices***

1. Wearable Market trends

■ What is current wearable applications?



1-1. Fitness and Wellness - Bracelets

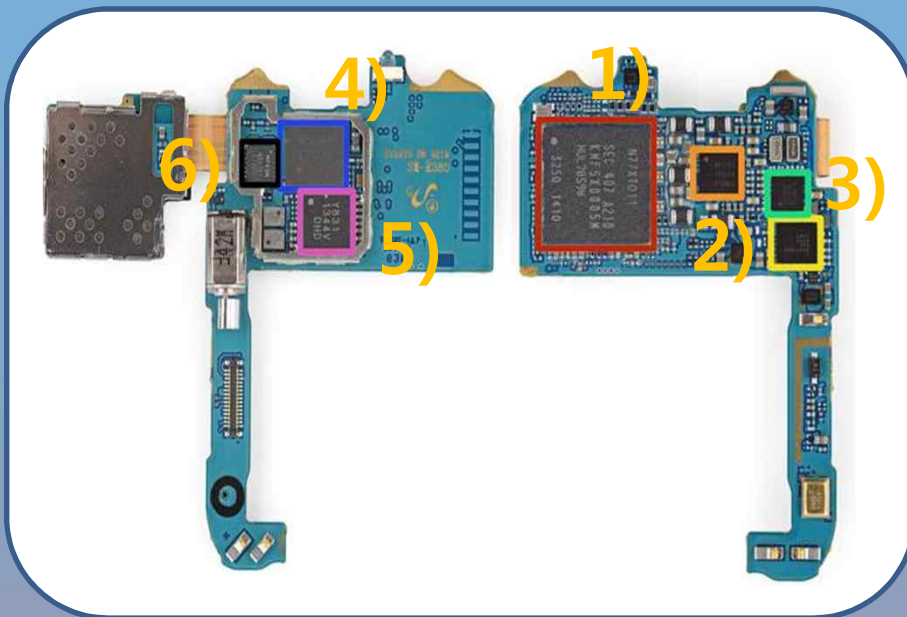
○ Bracelets Teardown (Jawbone)



Rigid Substrate locate the right location to avoid bending reliability issues
The Interconnection is connected by **FOB between Rigid and FPC.**

1-2. Informative Device - Smartwatch

■ Tear-down of galaxy gear 2



1. Samsung KMF5X0005M AP
(DRAM package, 1 GHz dual-core CPU)
2. Maxim Integrated MAX77836
(likely micro-USB interface controller and battery)
3. STMicroelectronics [32F401B](#)
32 bit ARM Cortex MCU
4. 0225E8 E225B4
5. BCD Semiconductor [Y831](#) audio code
6. InvenSense MP65M
6-axis gyroscope / accelerometer

1-2. Informative Device – Smart Glass

○ Google Glass

- Competitor : Samsung Gear Glass Launch (2014, 2Q)

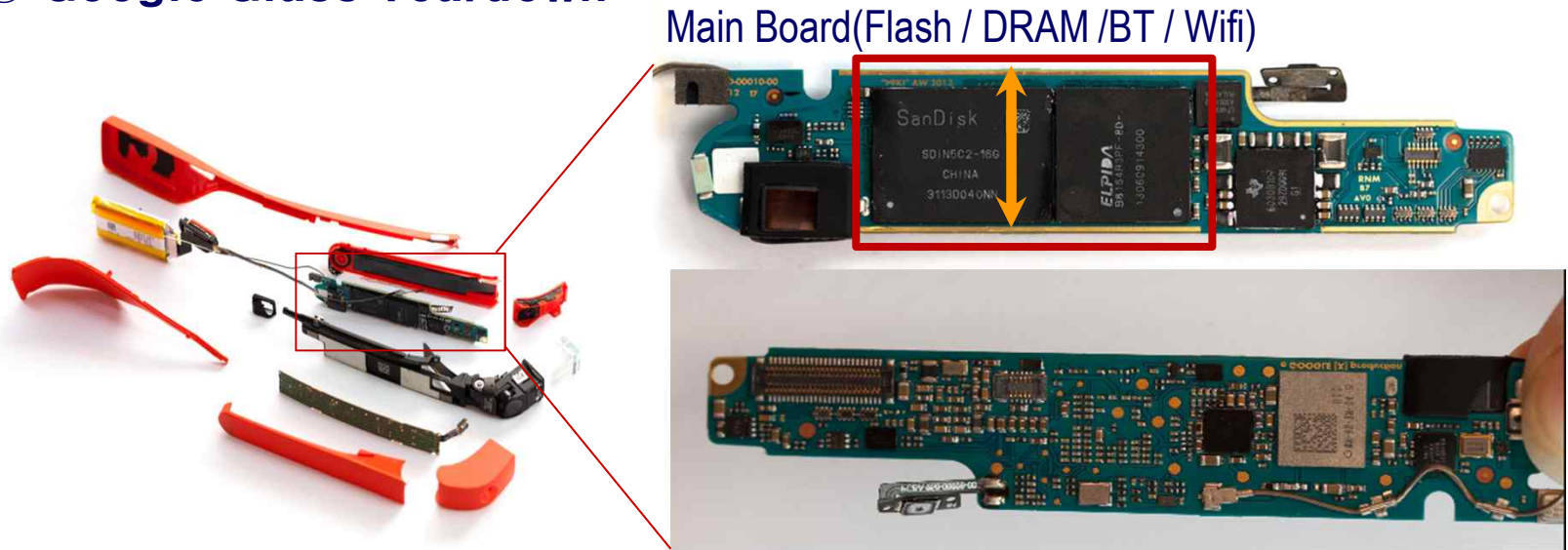


Add Substructure to the glasses

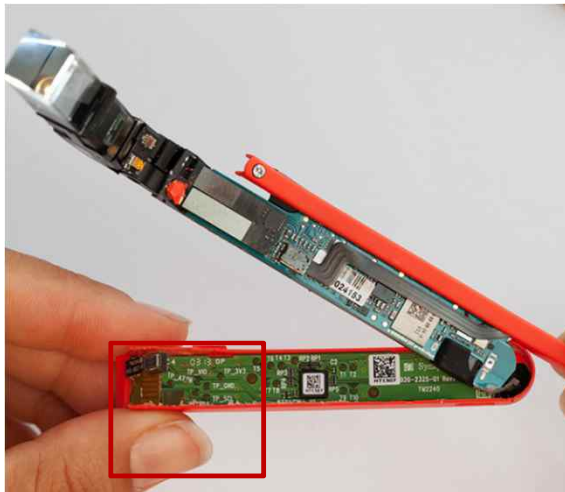
Item	Component	Remark
S/W	Android	4.0.4
Display	640×360 display	nHD (640 x 360) Display
Active Device	AP	Texas Instruments OMAP 4430 SoC 1.2Ghz Dual(ARMv7) → Special Order
	DRAM	1 GB Mobile DRAM (Elpida)
	Flash	16GB storage (12 GB available)
	Sensor	MEMS : 3 axis gyroscope 3 axis accelerometer 3 axis magnetometer (compass)
	Wireless Communication	Bluetooth, Wi-Fi <u>Bone conduction</u> transducer
Camera	5-megapixel	capable of 720p video recording
Charger		Included Micro USB cable and charger
Battery		Single-cell Li-Polymer Battery at the end flexprint PCB(2.1Wh)

1-2. Informative Device – Google Glass

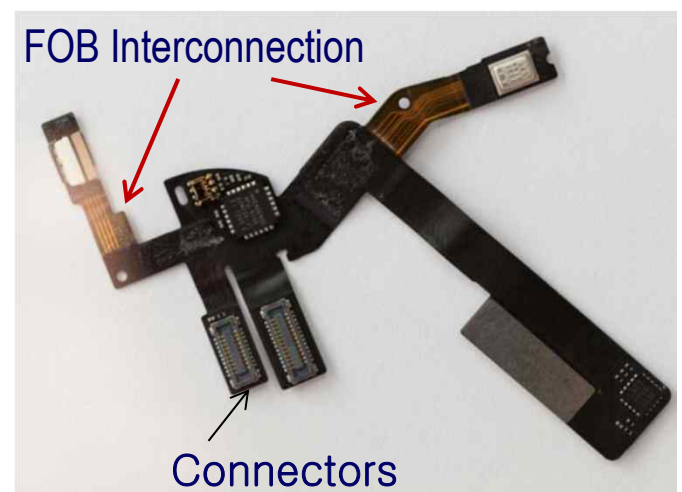
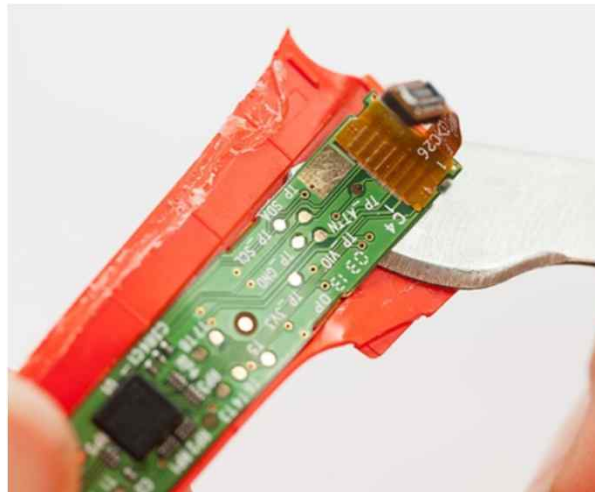
○ Google Glass Teardown



Sub Board



Touch Interface



Rigid PCB, FPC, solder SMT, Connector based interconnection

1-3. Healthcare & Medical – Wearable sensors

○ Advanced Wearable Sensors

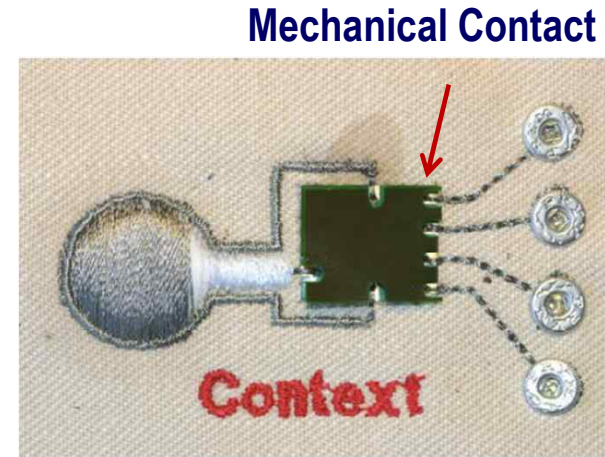
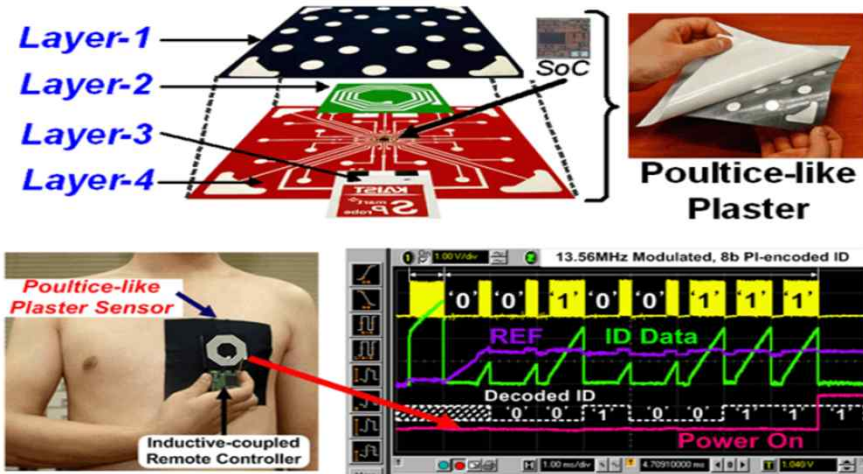


Fig. 9 Embroidered Sensor with interconnections to the electronic module and snap fasteners as interface to the computer

Fabric Wire interconnection(IZM 2013)

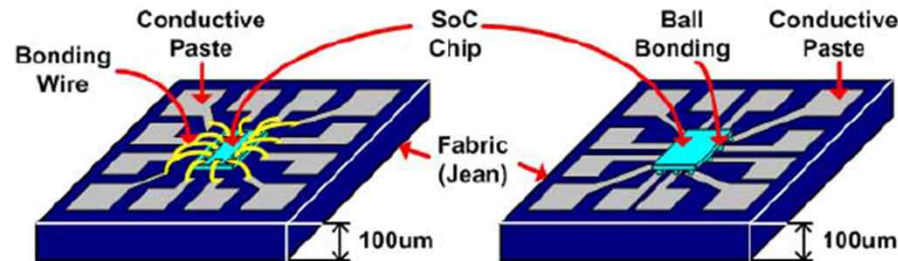
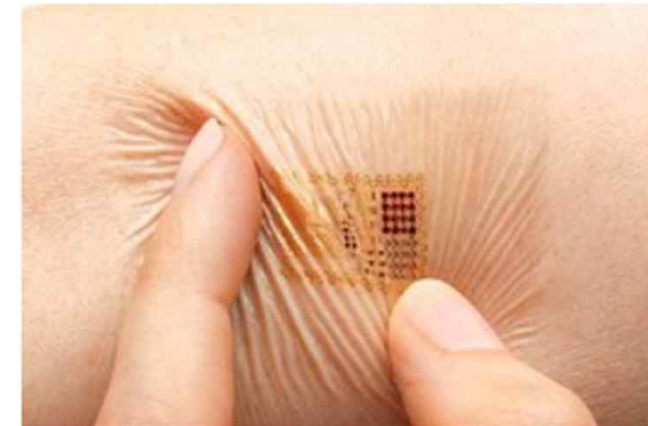


Fig. 5. Silicon-on-Clothes: direct integration of silicon onto P-FCB

SOC(Silicon on Clothes) sensor, (Hoi-Jun Yoo, KAIST)

Interconnection is challenging!



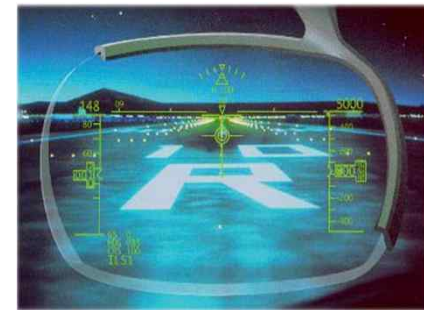
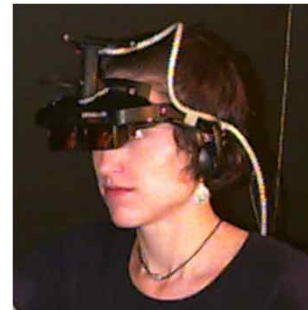
Flexible electronics from MC10 on a person's arm.

* Source : ETRI (바이오의료 IT융합연구부, 2013.07)

1-4. Industrial and Military

4. Industrial and military

- Application : Hand worn terminals, Augmented reality heat-sets etc.



Head Up Guidance System (HGS)
(Flight Dynamics Inc.)



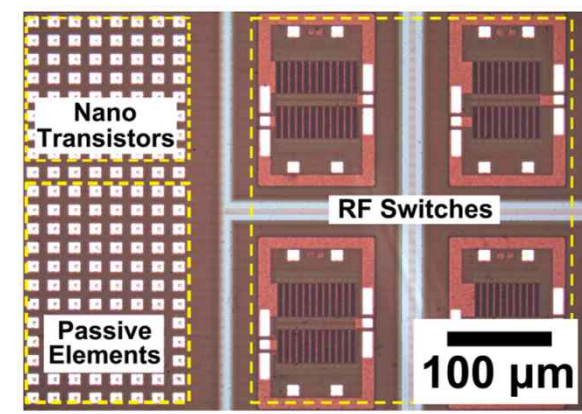
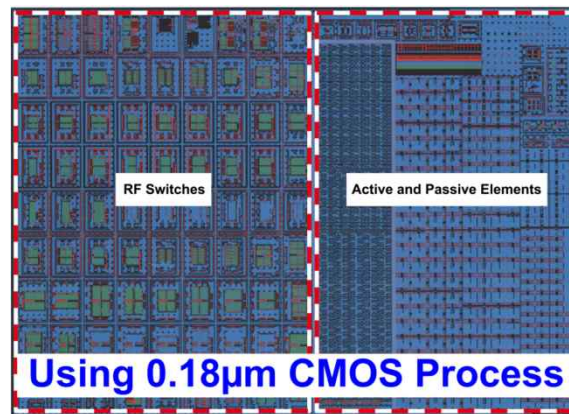
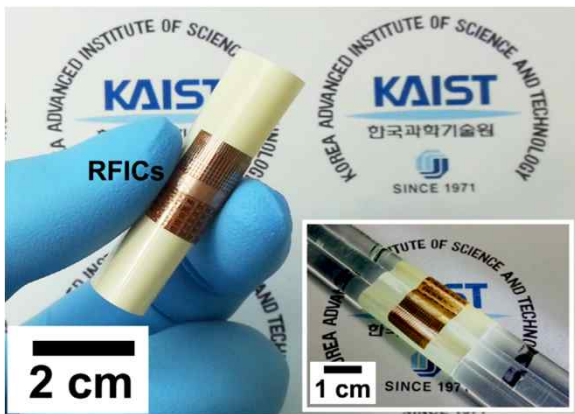
Hand worn terminals
(WT41N0) Motorola



Flexible/Wearable Electronics 4 Core HW Technologies

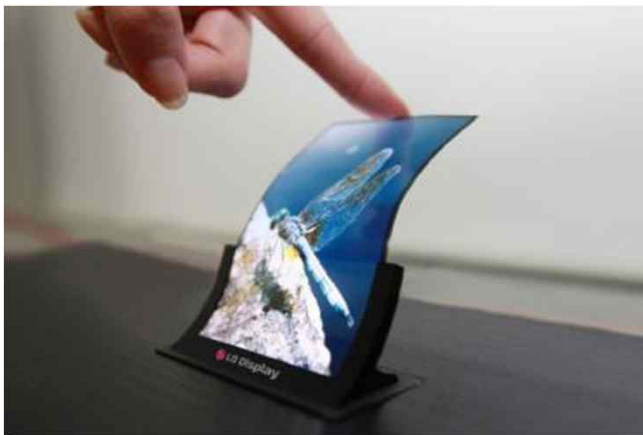
1. Flexible LSI Devices
2. Flexible Batteries
3. Flexible Displays
4. Flexible Packages & Assembly
 - Flexible Interconnect
 - Connector-based : Not good for flexibility
 - Solder-based : Not good for flexibility
 - **ACF-based**
 - Flexible IC Packages – **ACF COF/CIF**
 - Flexible Connectors – **ACF FOB /FOF**

1. Flexible LSI Device



ACS Nano, 7(5), 4545, 2013

2. Flexible Display - OLED



LG Display's **Flexible Display**



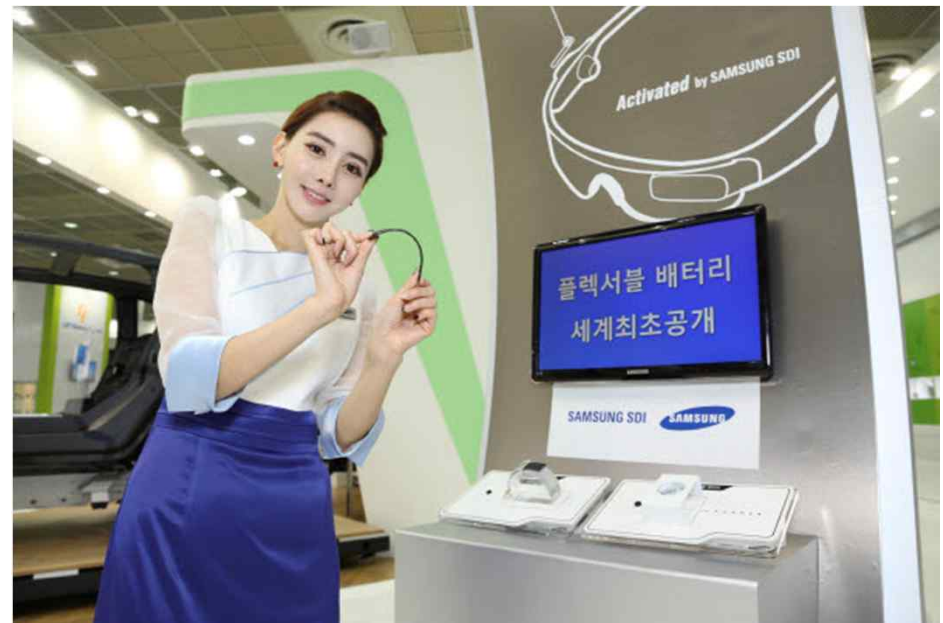
LG's G Flex Smartphones



Samsung's Curved Smartphones using **OLED** on Polymer films



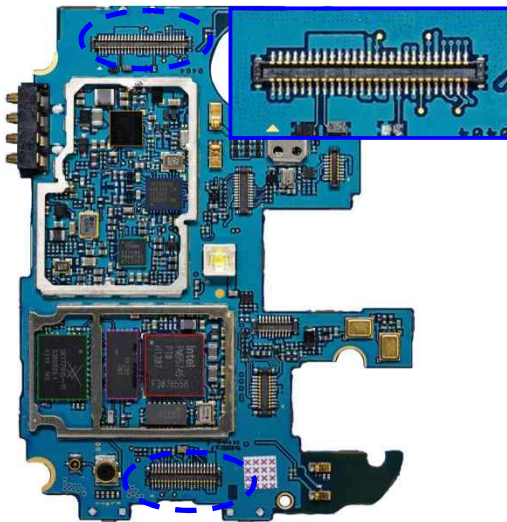
3. Flexible Battery



Anisotropic Conductive Films (ACFs) for flexible electronic packaging

- General 3 electrical connection methods

1) Pressure interconnection

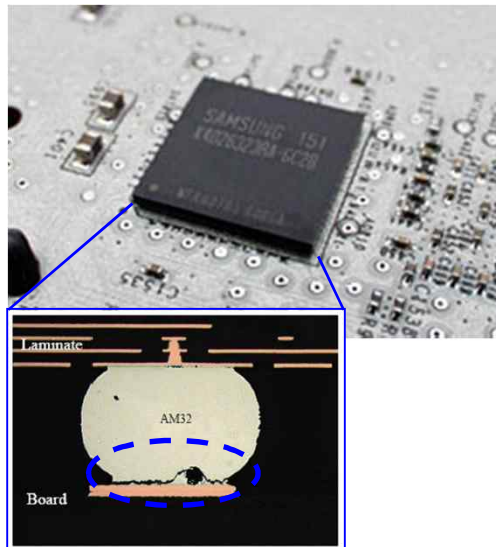


Source) Samsung Galaxy S4

No flexibility

2) Solder interconnection

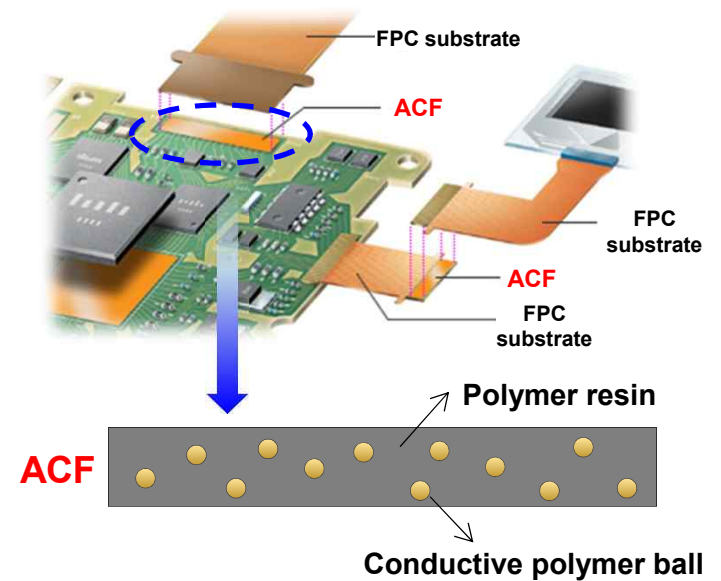
Source) Samsung



Fatigue solder crack

3) Adhesive interconnection

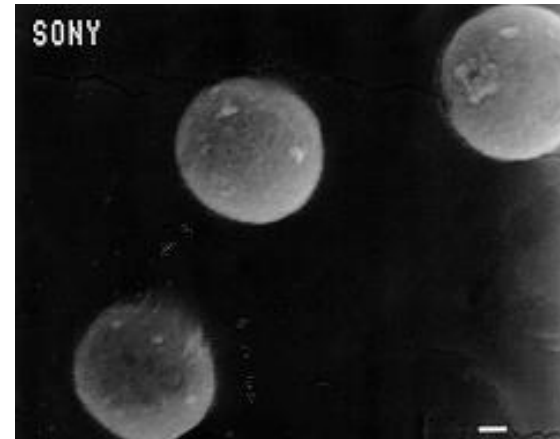
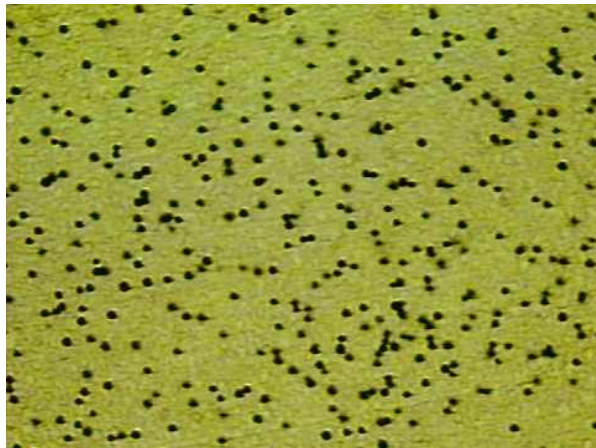
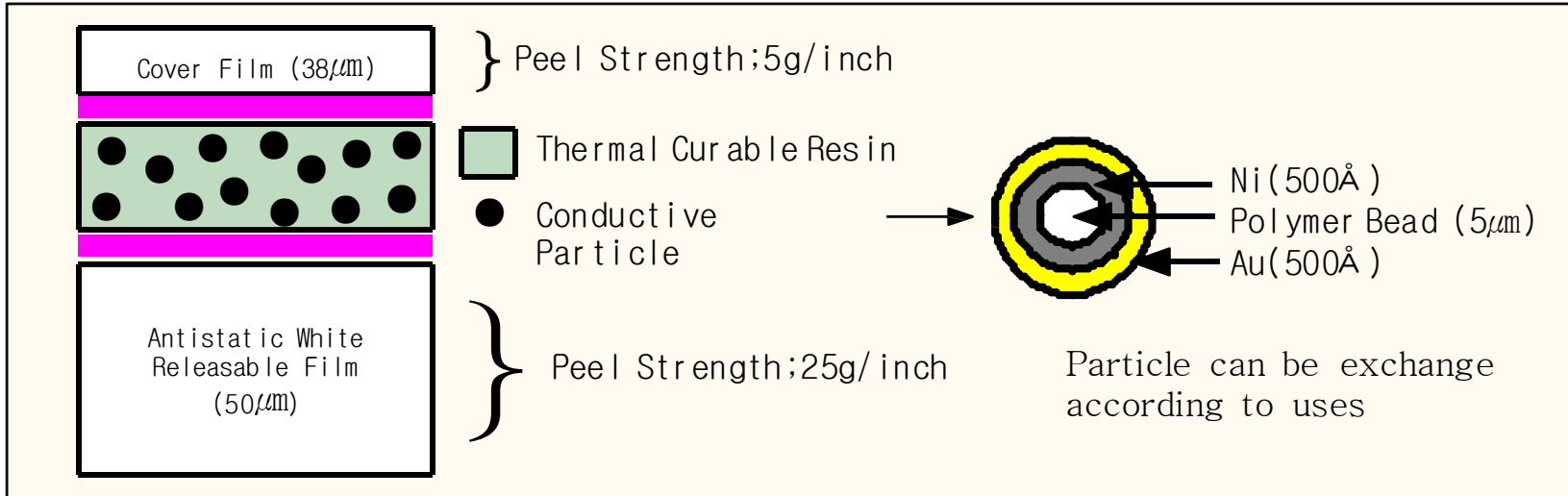
: ACF (Anisotropic conductive film)



Flexibility

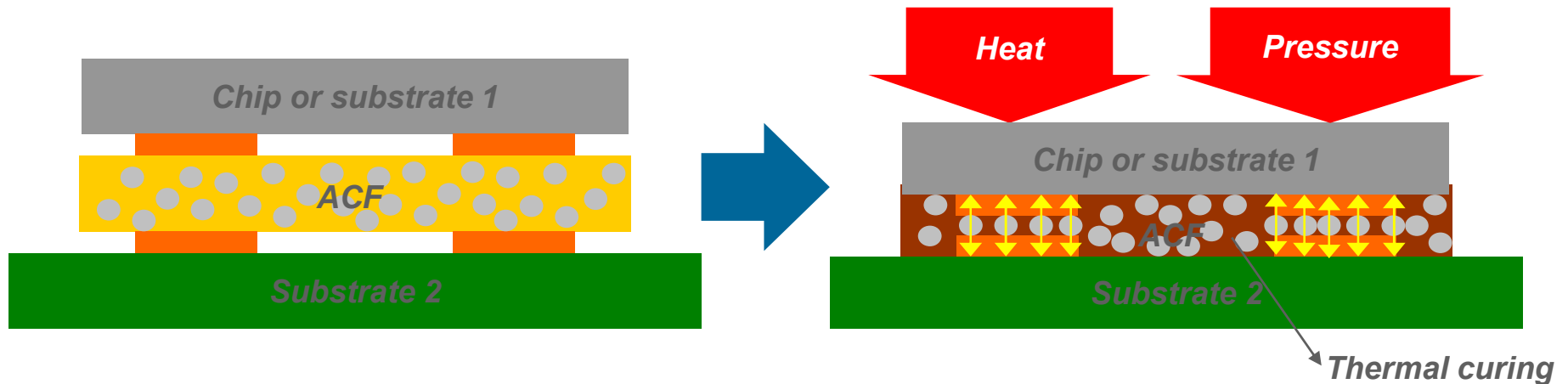
ACF configuration

《CONFIGURATION》

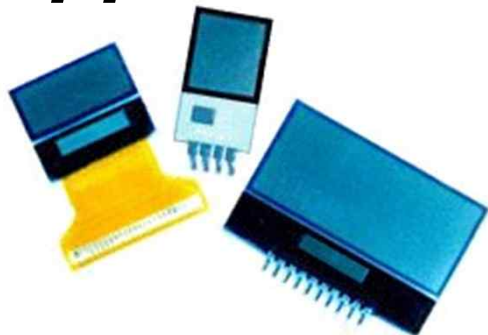


Anisotropic Conductive Films (ACFs)

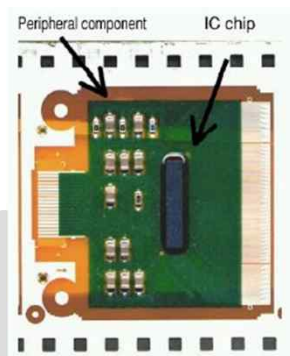
- **ACF** = Thermosetting epoxy resin film + Conductive particles



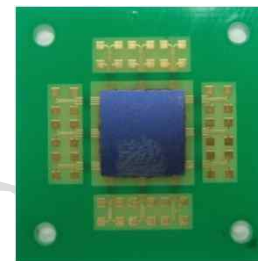
- **Applications of ACFs assembly**



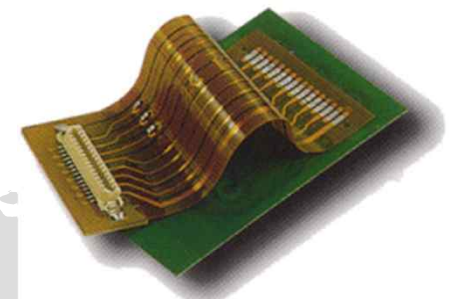
Chip-On-Glass (COG)
Chip-On-Flex (COF)
Flex-On-Glass (FOG)



Chip-On-Flex (COF)



Chip-On-Board



Flex-On-Board (FOB)

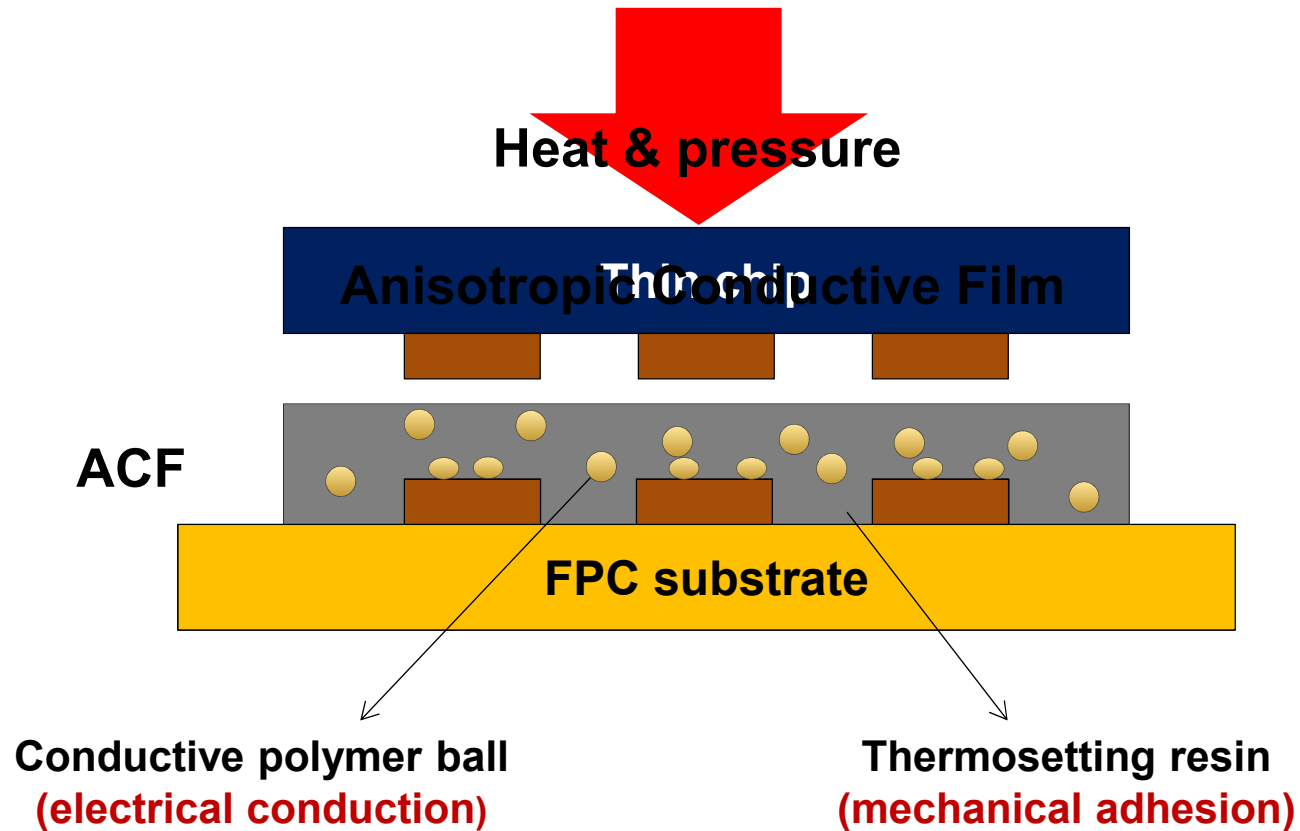
Issues on ACF flexible package structure for wearable electronics

1. Flexible IC Package geometry design
2. Optimization of ACF materials
 - ACF Polymer Resin & Conductive balls
3. Fine pitch ACF interconnect
 - Nanofiber ACFs (>20 um pitch)
4. Current carrying capability
 - Solder ball ACFs + Ultrasonic bonding
5. Reliability

Issues on ACF flexible package structure for wearable electronics

- 1. Flexible IC Package geometry design**
- 2. Optimization of ACF materials**
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- 5. Reliability**

Anisotropic Conductive Films (ACFs) for flexible chip electronic packaging

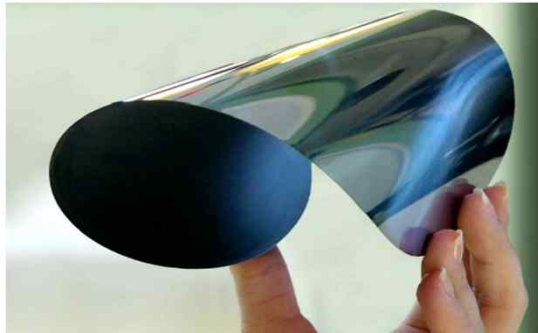


Chip-on-Flex package using ACFs is suitable for flexible package structure.

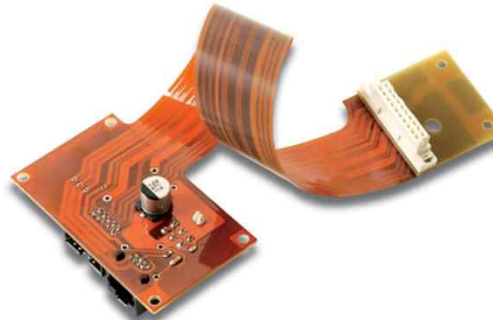
COF/CIF Packages interconnected using ACFs

Materials & interconnection type

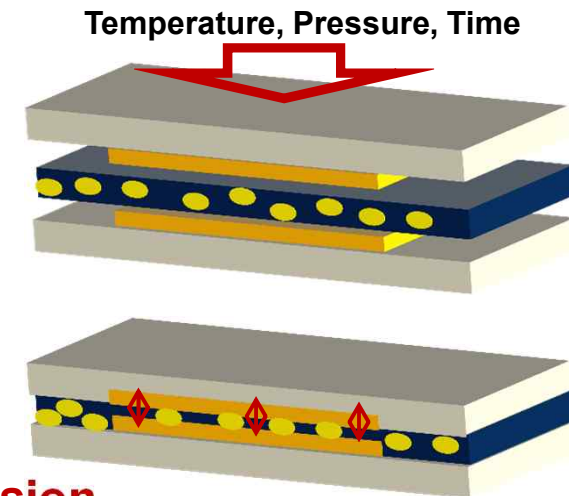
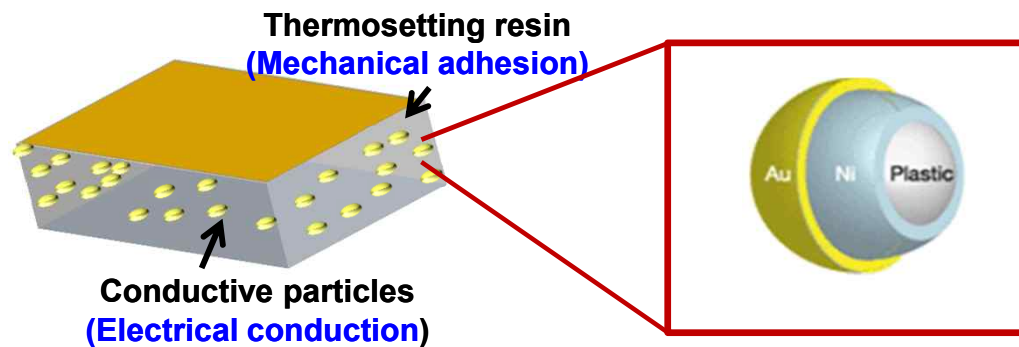
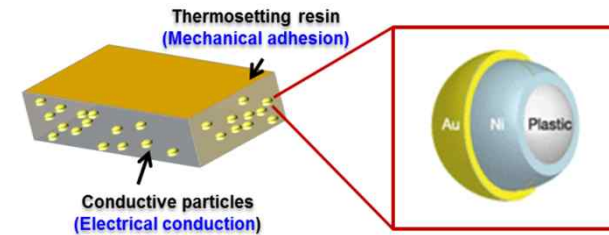
Ultra-thin Silicon chip
(30um~40um)



Flexible Substrate
(Polyimide Film)



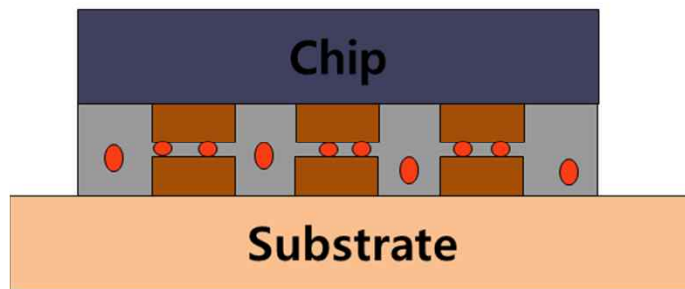
Flexible Interconnect
using ACF



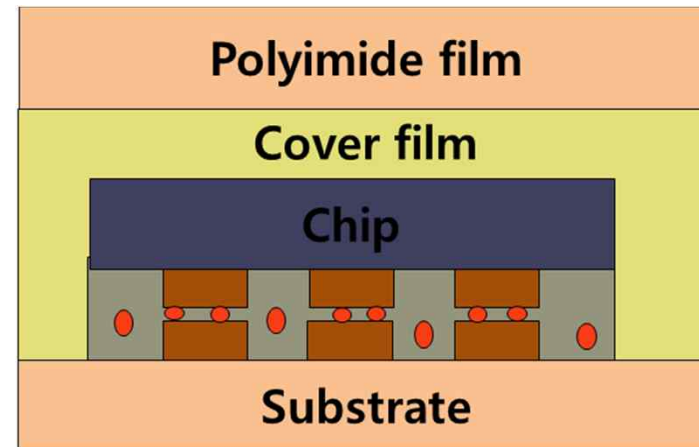
Conductivity, Insulation, Adhesion

1. Flexible IC Package geometry design:

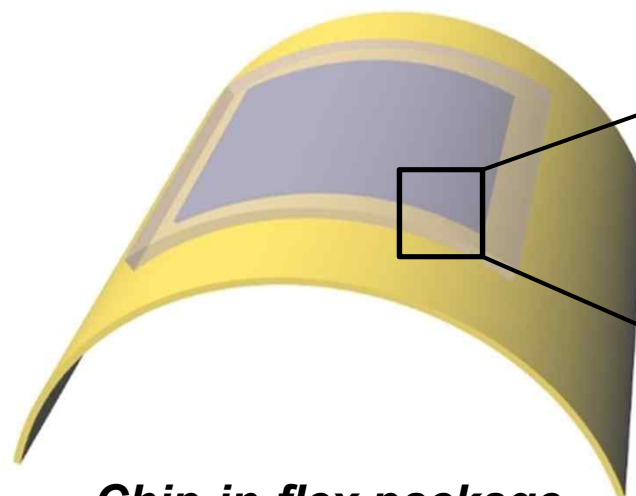
COF(Chip-on-Flex)/CIF(Chip-in-Flex) package using ACFs



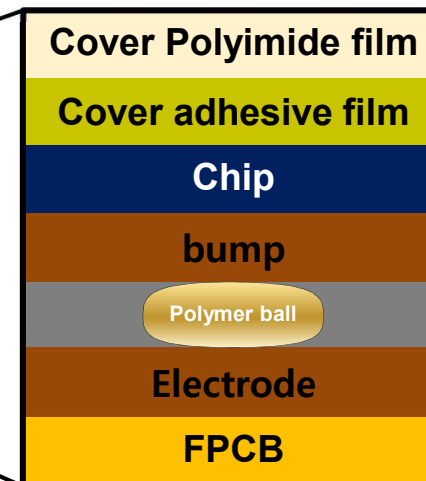
COF(Chip On Flex)



CIF(Chip In Flex)



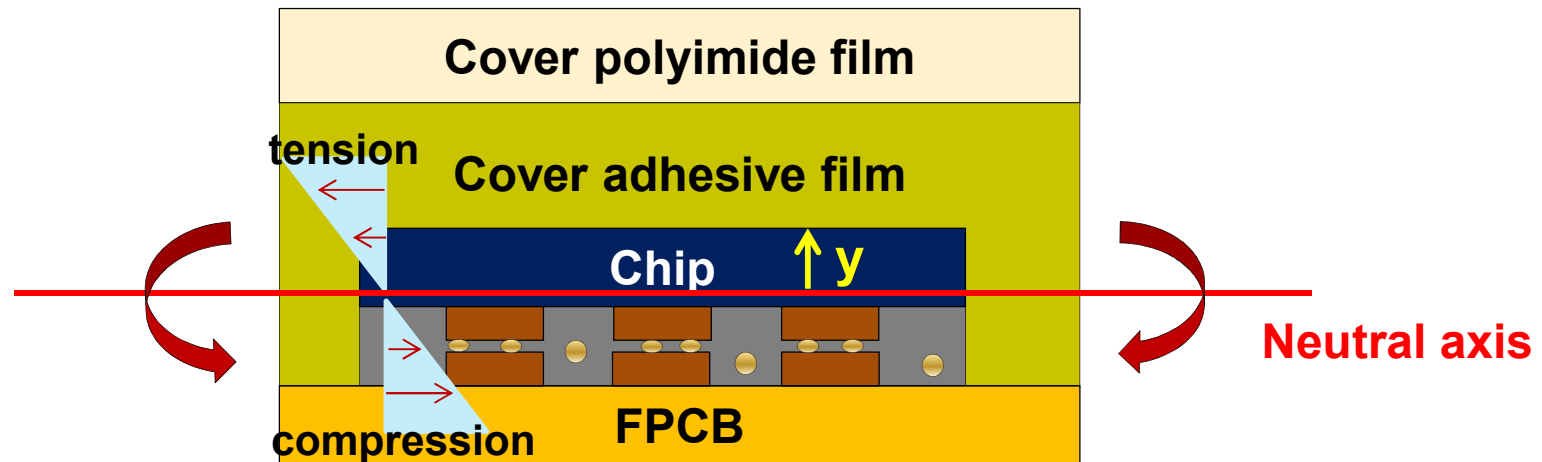
Chip-in-flex package



ACF resin

Location of the Neutral axis & the Maximum Tensile Stress depending on Package Structure & Package Geometry

Chip-in-Flex :



Neutral axis : axis with no strain or no stress

<Position of Neutral axis>

$$y_N = \frac{\sum_i E_i \int_{A_i} y' dA}{\sum_i E_i A_i} = \frac{\sum_i E_i \bar{y}_i A_i}{\sum_i E_i A_i}$$

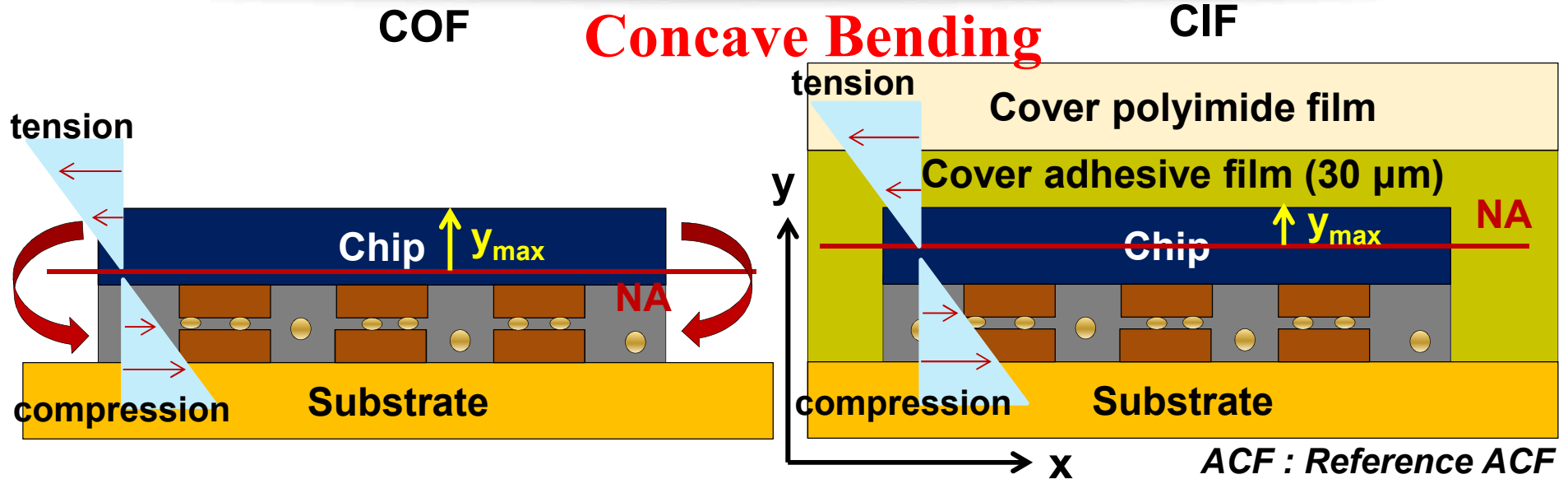
y_N = neutral axis
 E = elastic modulus
 \bar{y} = distance from bottom
 A = cross – sectional area

<Maximum tensile stress on the chip surface>

$$\sigma = \frac{E_{si} \times y}{\rho}$$

σ = bending stress
 E = elastic modulus
 y = distance from neutral axis
 ρ = bending radius

The location of the Maximum tensile stress on the chip surface depending on COF/CIF packages



<Maximum tensile stress on the chip surface>

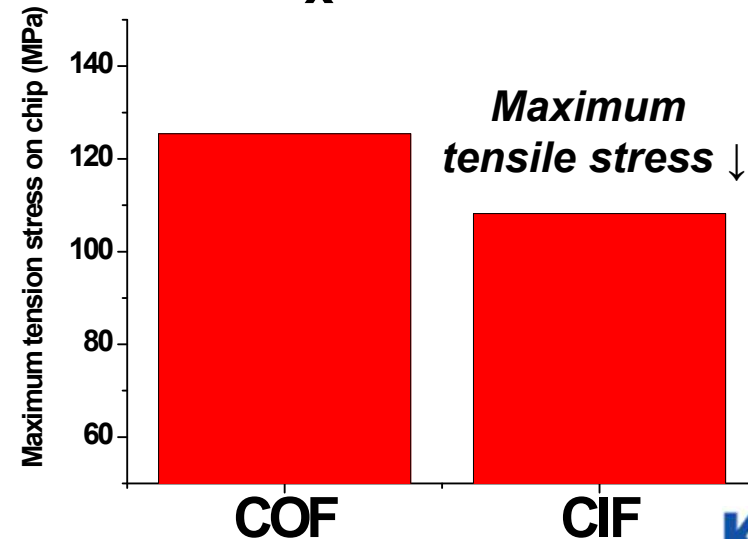
$$\sigma = \frac{E_{si} \times y}{\rho}$$

σ = bending stress

E = elastic modulus

y = distance from neutral axis

ρ = bending radius



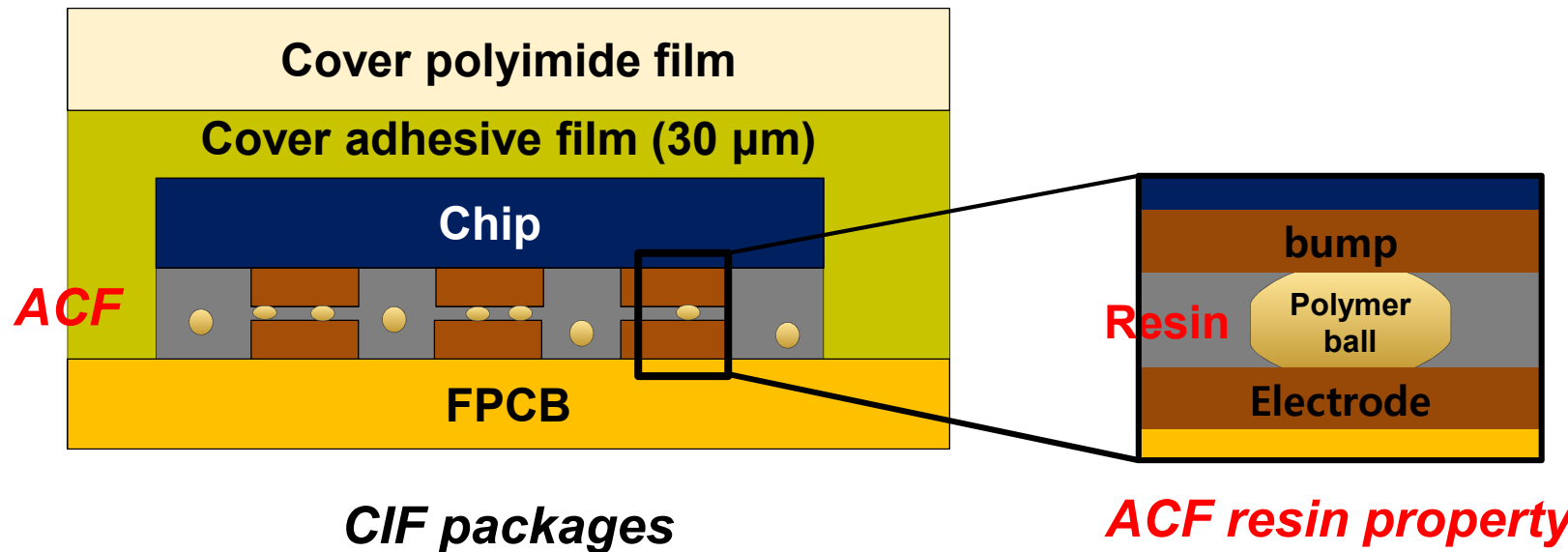
@ concave bending radius : 5mm

Issues on ACF flexible package structure for wearable electronics

1. Flexible IC Package geometry design
2. Optimization of ACF materials
 - ACF Polymer Resin & Conductive balls
3. Fine pitch ACF interconnect
 - Nanofiber ACFs (>20 um pitch)
4. Current carrying capability
 - Solder ball ACFs + Ultrasonic bonding
5. Reliability

2. Optimization of ACF materials : ACF polymer resin property on the flexibility of CIF PKG

Evaluation of CIF package bending reliability depending on
ACF polymer resin property

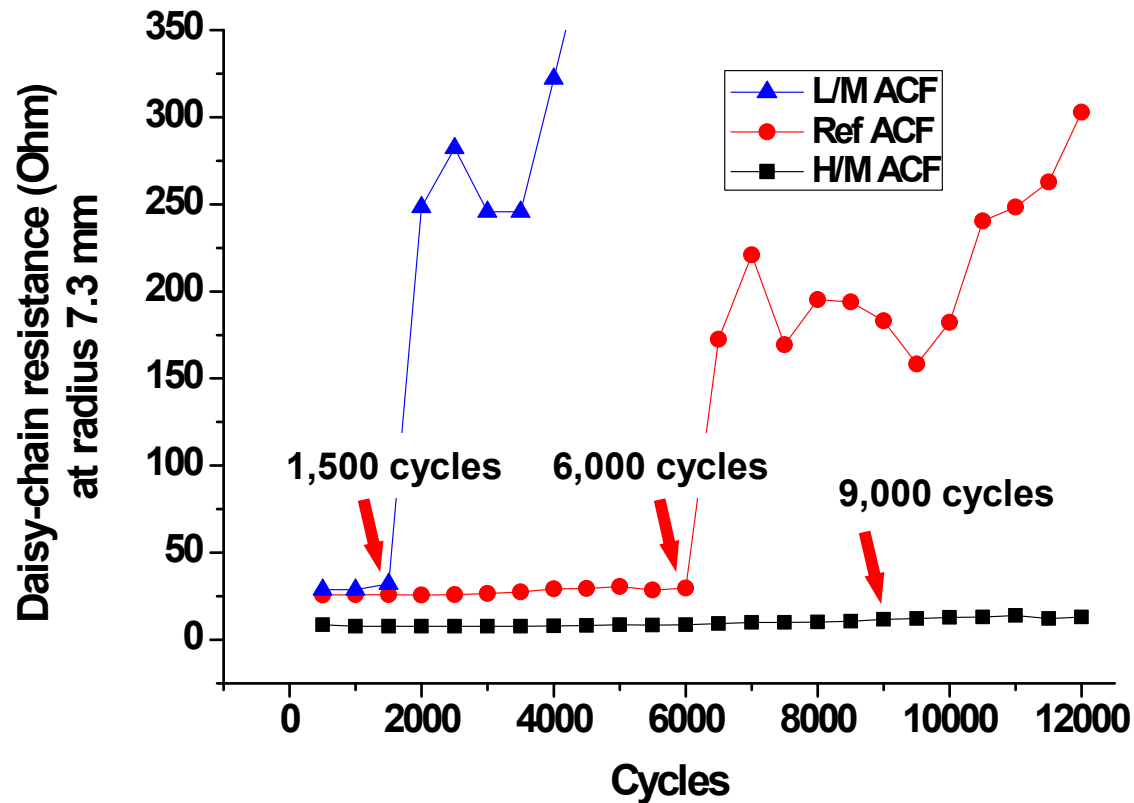


ACF	Modulus
Low modulus ACF	0.9 GPa
Reference ACF	1.57 GPa
High modulus ACF	1.82 GPa

Effects of ACF resin properties on the flexibility of CIF PKG under dynamic bending test

ACF	Low modulus ACF	Reference ACF	High modulus ACF
Modulus	0.9 GPa	1.57 GPa	1.82 GPa

In-situ dynamic bending test
160k cycles (@ R7.3 mm)



As modulus of ACF increased, dynamic bending life increased.

Issues on ACF flexible package structure for wearable electronics

1. Flexible IC Package geometry design
2. Optimization of ACF materials
 - ACF Polymer Resin & Conductive balls
3. *Fine pitch ACF interconnect*
 - Nanofiber ACFs (>20 um pitch)
4. Current carrying capability
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UHD: 4K Technology

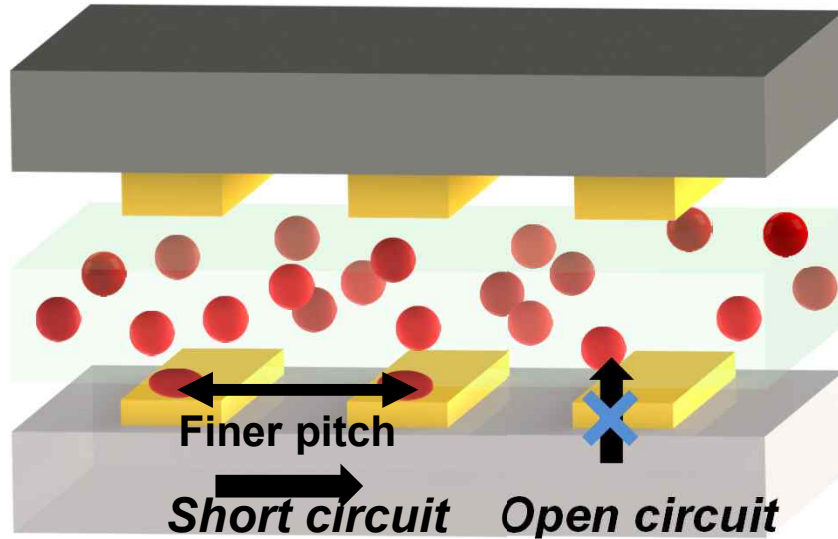


Samsung unveils its entire UHD TV lineup at CES 2014, leading with a 110-inch monster.

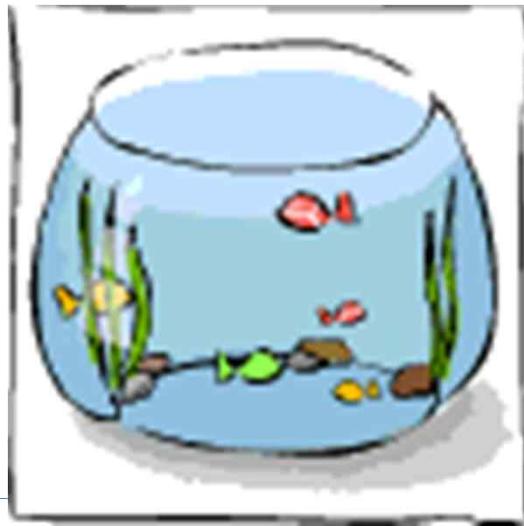
UHD(Ultra High Definition) & QHD(Quad High Definition) LCD panel requires **ultra fine pitch I/O interconnection!**

Issues for Fine Pitch Interconnection Using ACFs

□ Unstable electrical performances on fine pitches



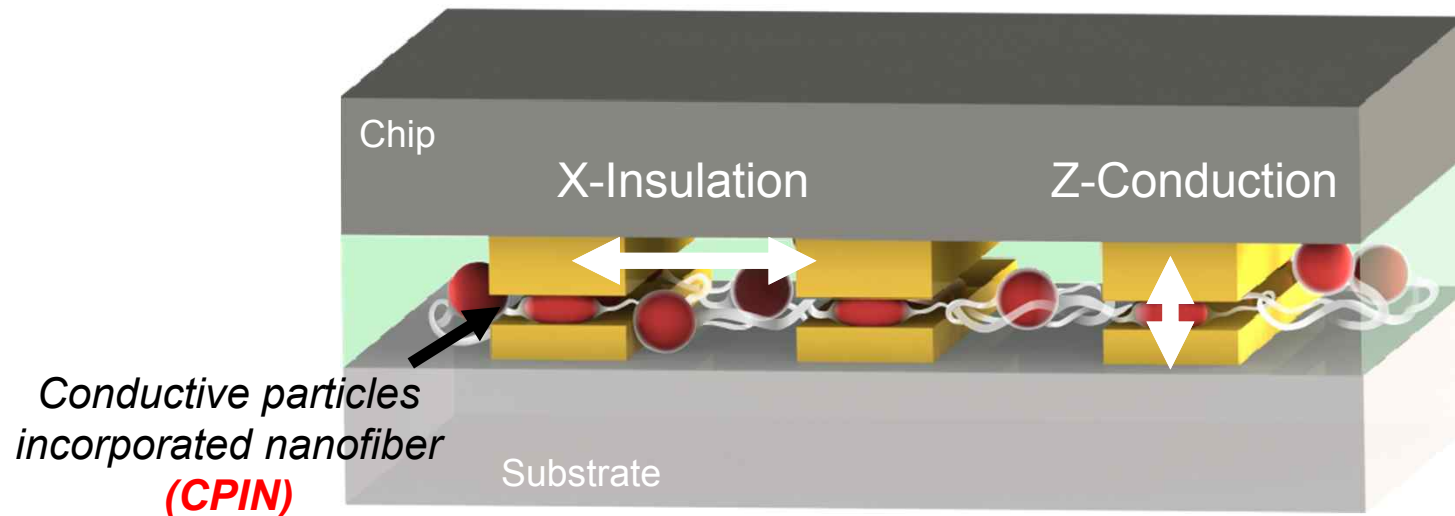
- **Short circuit:** agglomerated CPs
→ electrical conduction in X-axes
- **Open circuit / high resistance:**
Non-captured or small # of CPs in Z-axis
→ higher joint resistance
→ poor reliability



"Gulbi" at Korea

Why Nanofiber ACFs?

Nanofiber ACF



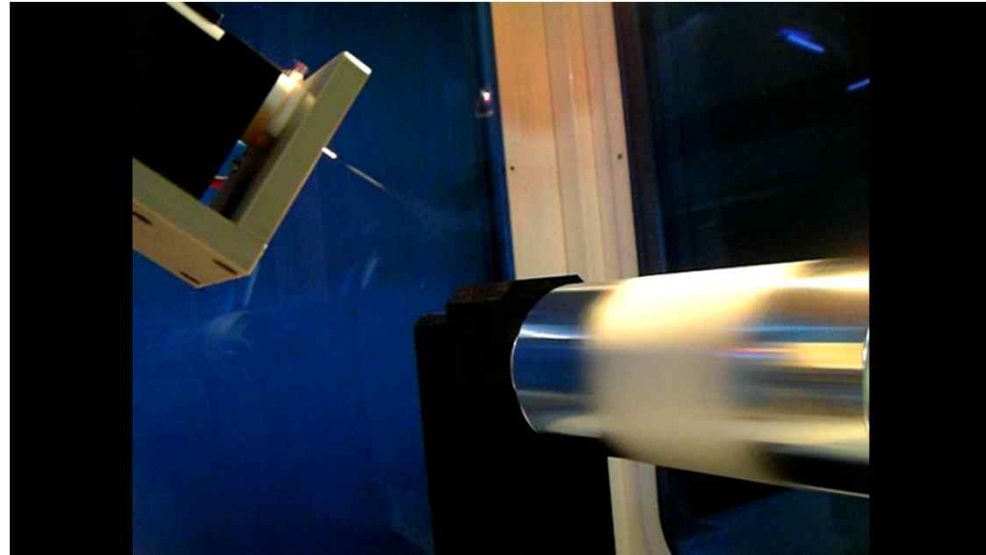
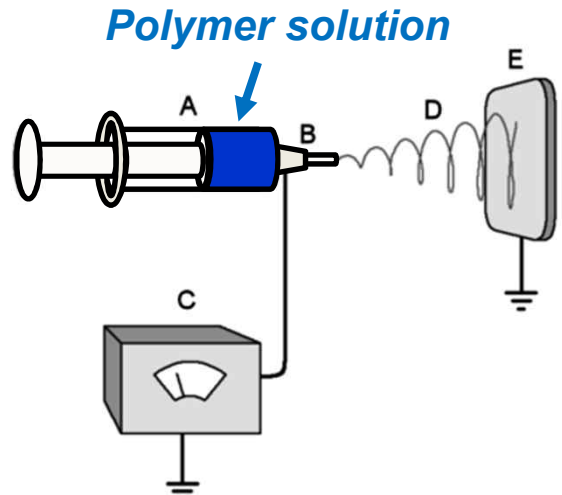
- ❖ Korea patent
:10-1115686 (issued)
:10-1146351 (issued)
:10-1160971 (issued)
:10-2011-0022041
- ❖ PCT patent pending
:PCT/KR2010/006623
- ❖ USA patent pending
:13/075,147
- ❖ Japan patent pending
:2011-072488
:2012-532008
- ❖ China patent pending
:201110111458.0

**Suppressing CP movement
→ No short circuit & open circuit**

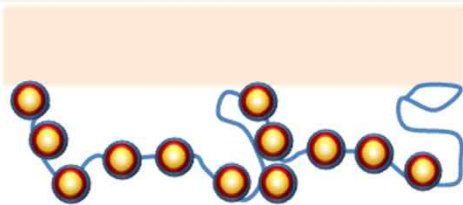
Ref) Kyoung-Lim Suk, Chang-Kyu Chung and Kyung-Wook Paik, 61st ECTC, Florida, USA, May 31-June 3, 2011.

Nanofiber ACFs Fabrication

□ Nanofiber formation by electro-spinning

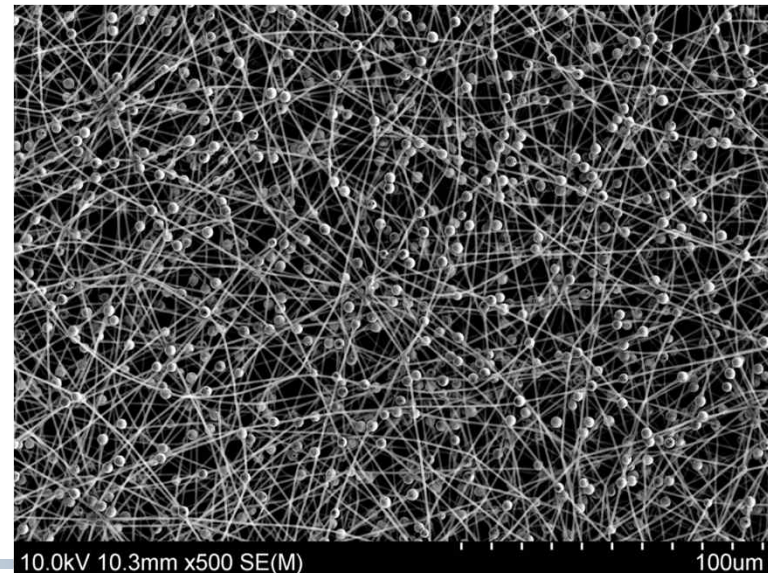


Type-B nanofiber ACF



NCF lamination (12 μm)

- NCF lamination on Conductive particle coupled nanofiber

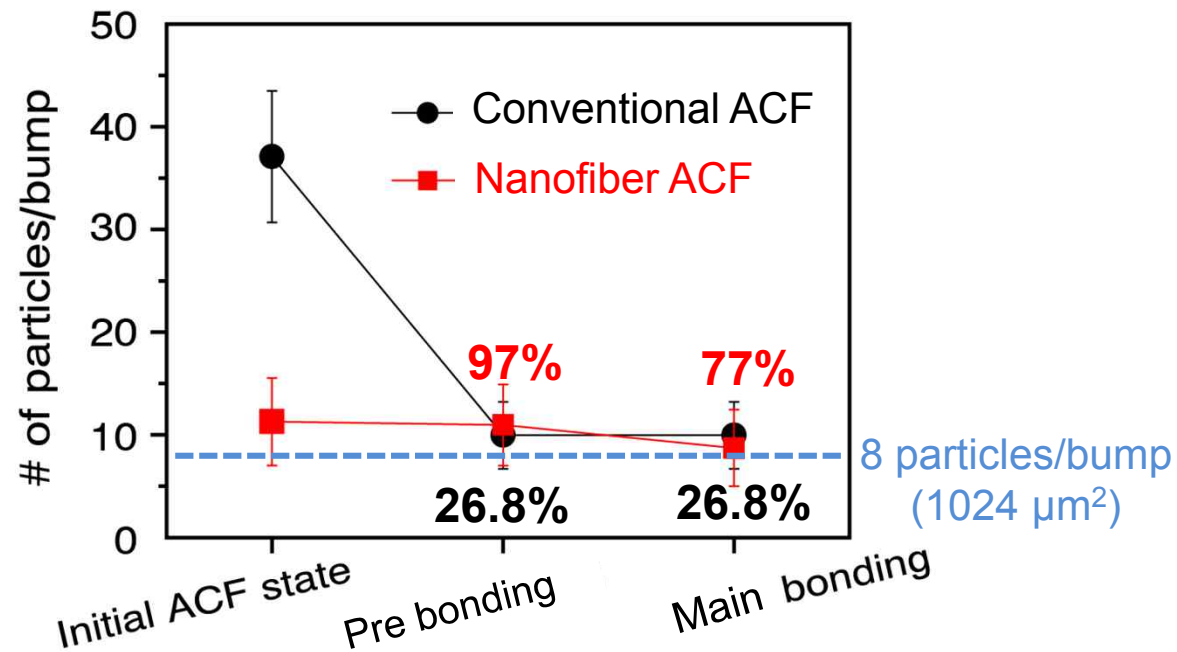
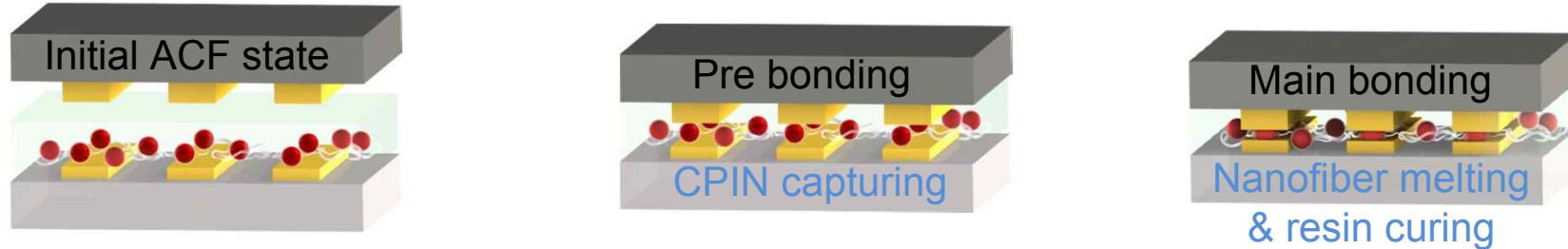


10.0kV 10.3mm x500 SE(M)

100 μm

Particle Capture Rate of Nanofiber ACFs

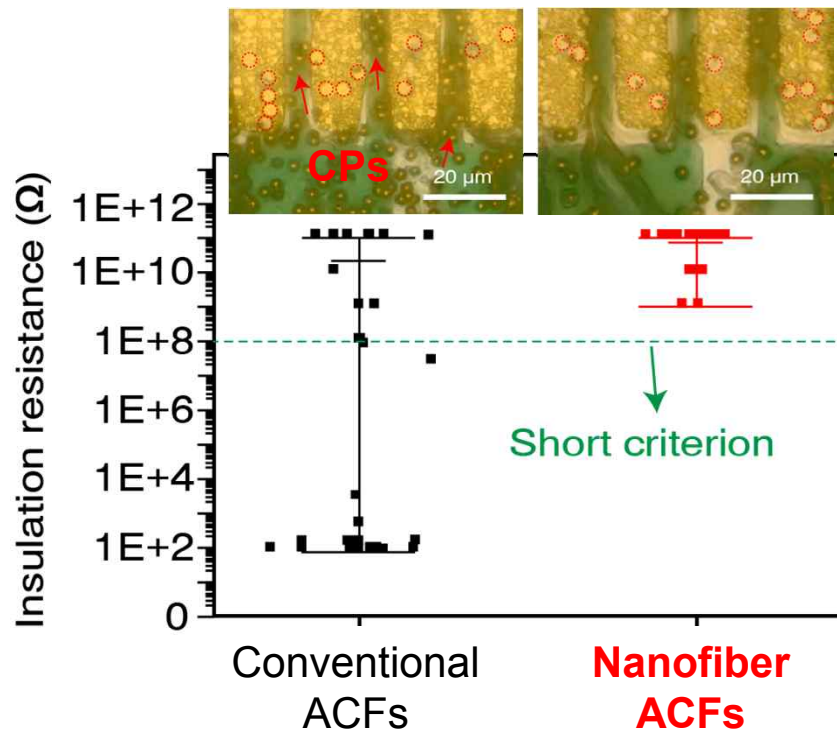
- Conductive particle movement during the bonding process



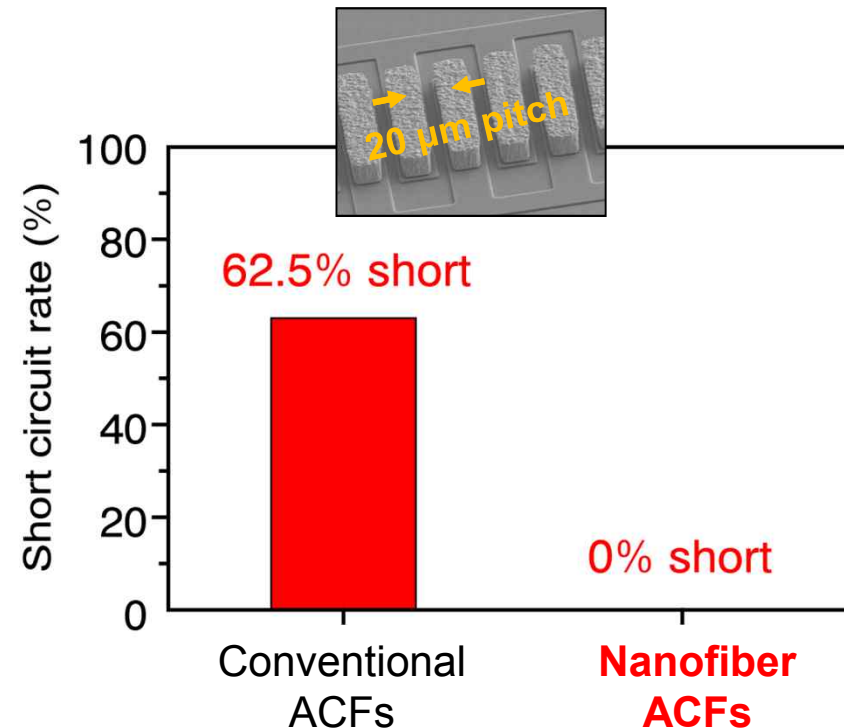
- Nanofiber ACF suppressed the particle movement** compared to the conventional ACF during resin flow.

Short Circuit Rate of Nanofiber ACFs

□ X-axis insulation resistance



□ Short circuit rate at 20 μm pitch



- ❖ Nanofiber ACF successfully suppressed the conductive particle movement resulting in zero short circuit rate at 20 μm pitch.

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4. **Current carrying capability**
 - Solder ball ACFs + Ultrasonic bonding
5. **Reliability**

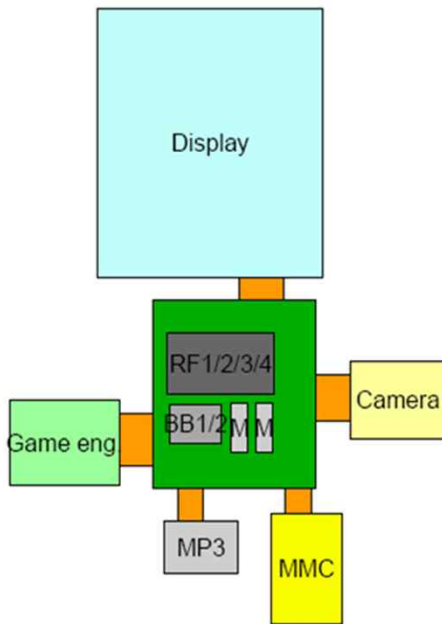
Recent issues in mobile device packages - Modulization

Current trends in mobile devices

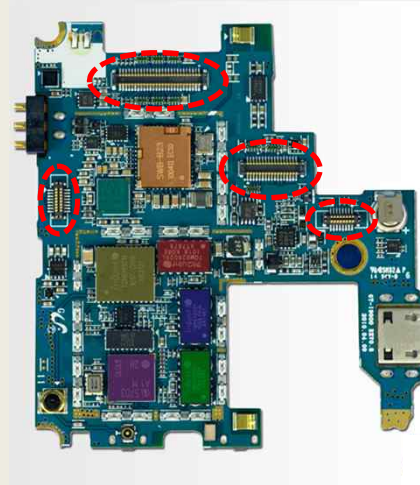


Source : Nokia

1. High performance
2. Multi-functionalization
3. Miniaturization



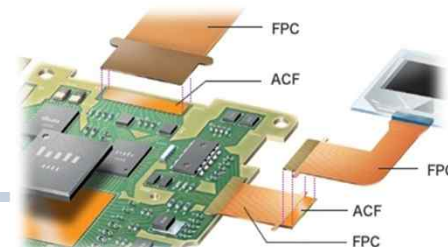
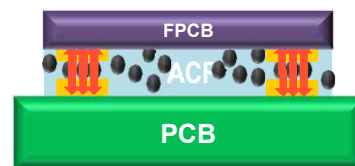
Conventional **Socket-type** connectors



✓ Disadvantages

- Large volume & height
- Large pitch size 400 um pitch

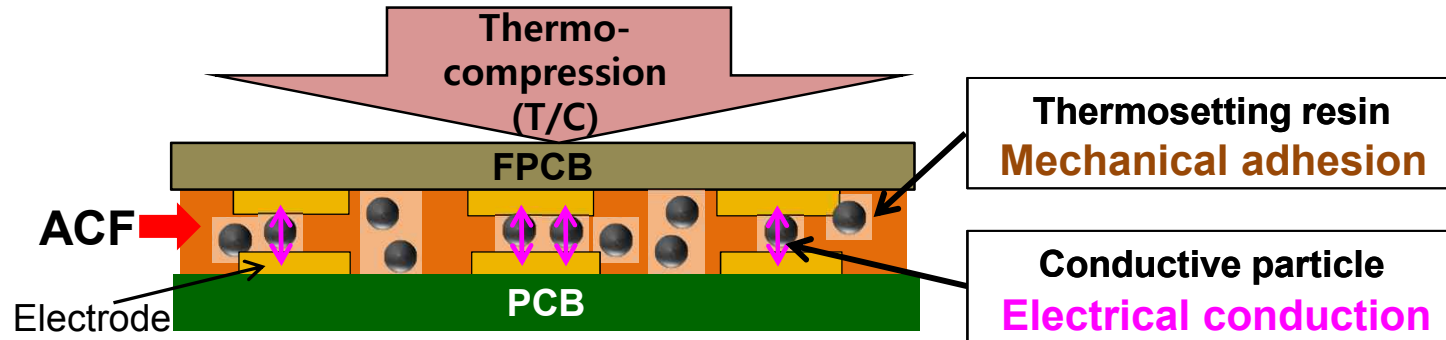
FOB(Flex-on-Board) & FOF (Flex) assembly using ACFs



✓ Advantages

- Fine pitch capability
- Reduced package size
- Process effectiveness

Anisotropic Conductive Films (ACFs) for FOB assembly



ACF FOB Advantages

<Conventional Socket-type connector>

- Large volume
- Large pitch size

<ACF bonding>

Rigid PCB

Flexible PCB

ACF

- Reduced package size
- Fine pitch capability

Source: Nokia

ACF FOBs in wearable devices

<Wearable device>

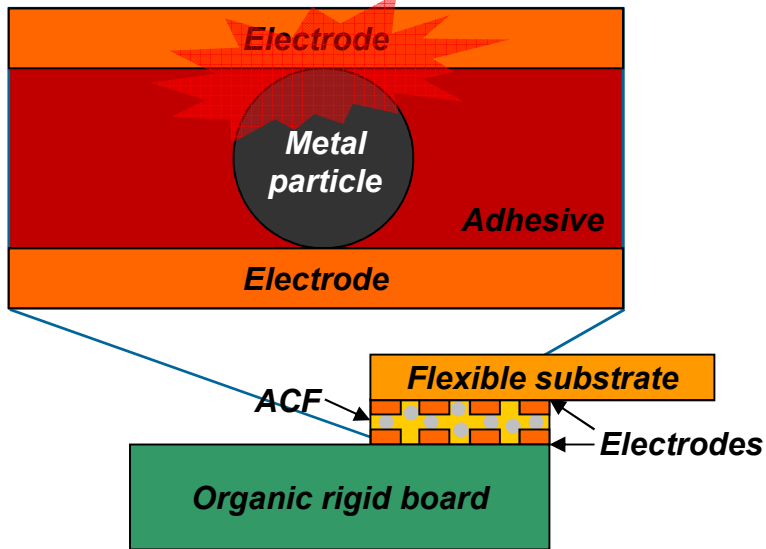
Galaxy Gear

Google glass

Source
: Samsung electronics
Google company

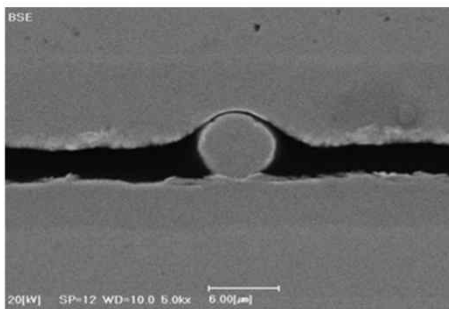
Solder ACFs for high current handling capacity

Conventional ACF

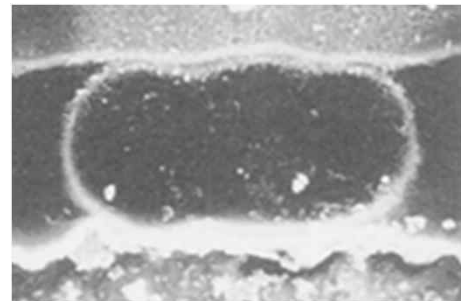


Physical point contact of metal particles

- Limitations in electrical properties and reliability



Ni ball

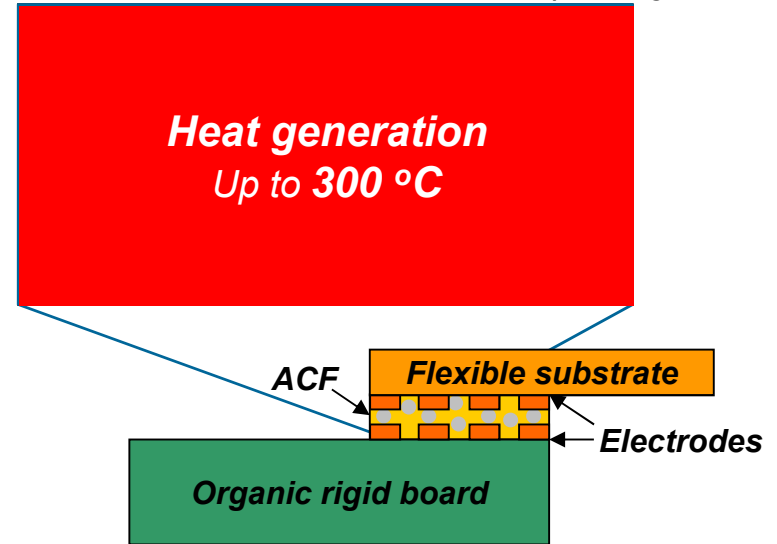


Metal coated polymer ball

Nano Packaging and Interconnect Lab.

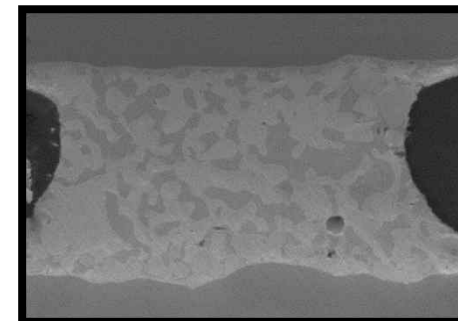
Solder ACF + U/S

Patent pending



Metallurgical bonding of solder particles

- Higher current carrying capability
- Improved reliability

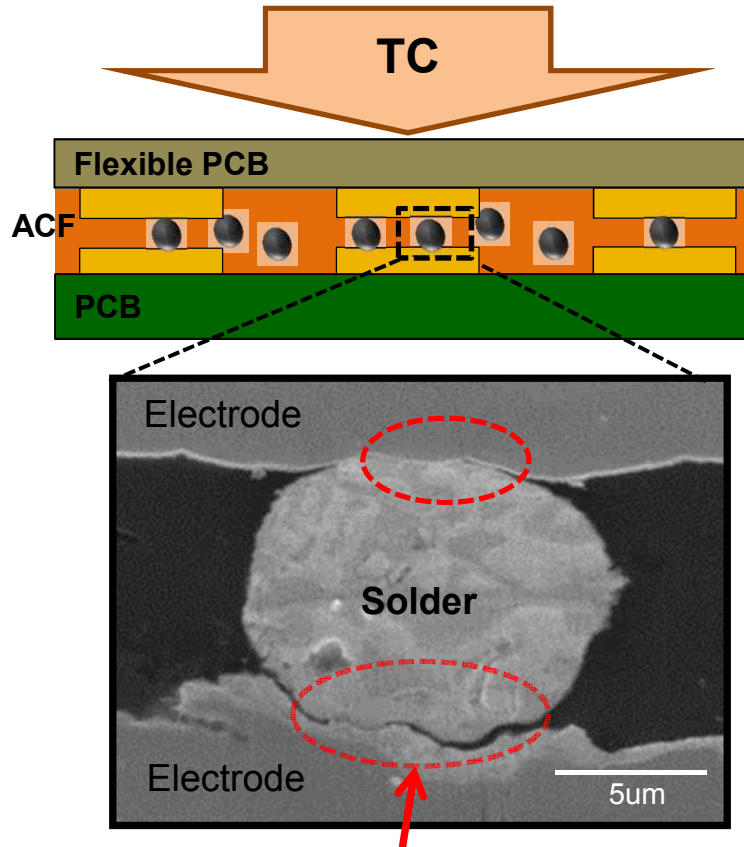


Solder ball

Solder particles in ACFs : Solder Oxide Layer problems

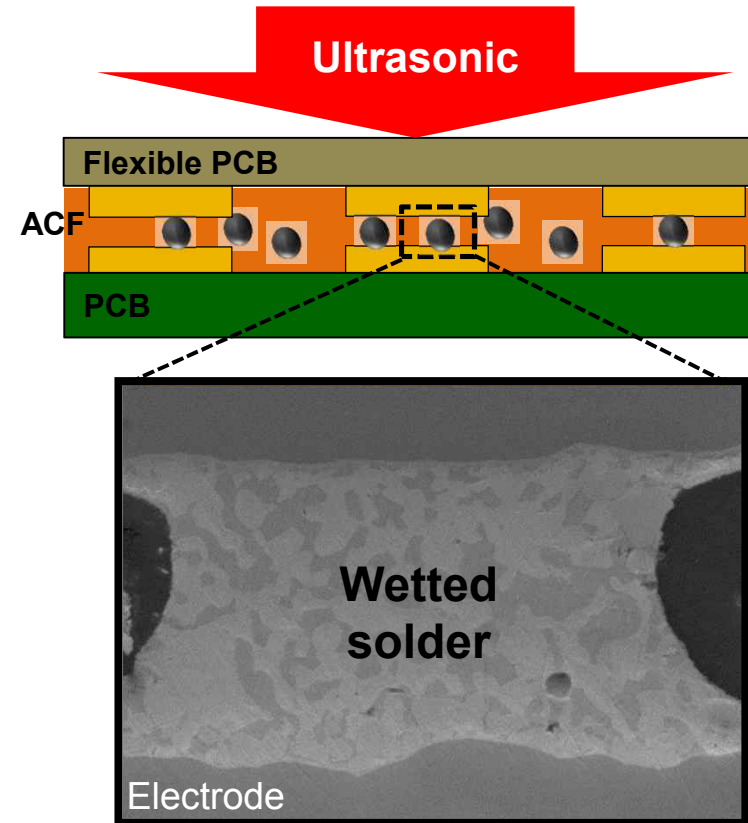
– Ultrasonic Bonding

- Thermo-compression (TC) bonding



**Partial solder wetting
by remained solder oxide layer**

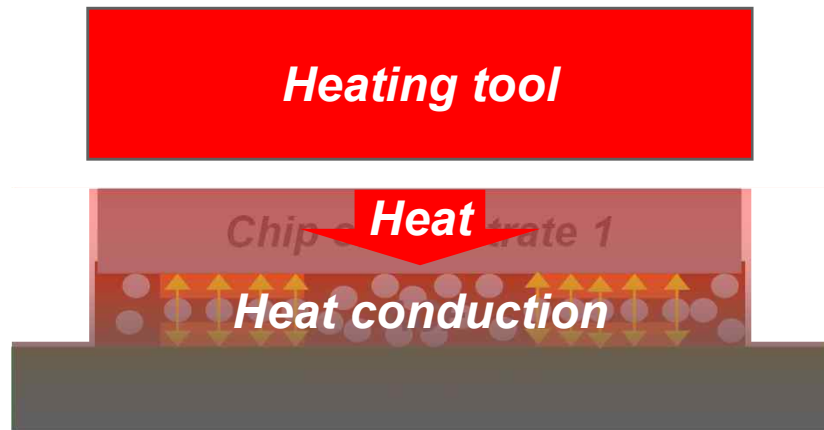
- Ultrasonic bonding



**Excellent solder wetting
by broken solder oxide layer**

ACFs bonding – Thermocompression(T/C) vs. Ultrasonic(U/S)

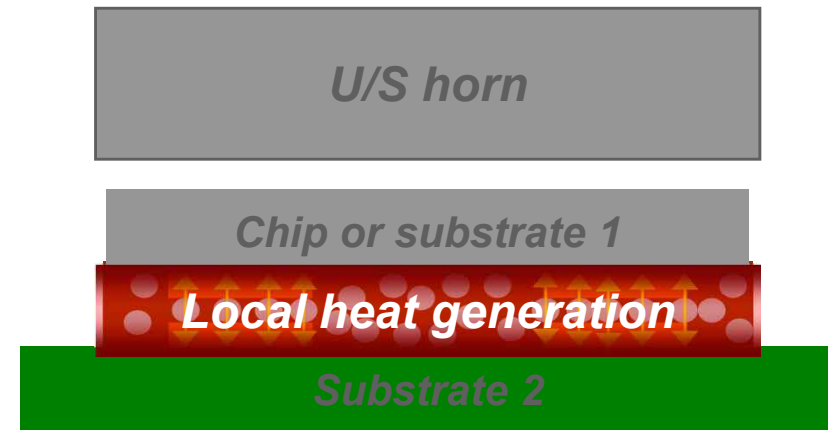
T/C ACFs bonding



Heating tool (**250 °C~350 °C**)
→ ACF temperature (**180 °C**)

- Thermal conduction – slow
- Thermal damages
- High Energy waste

U/S ACFs bonding *Patented*

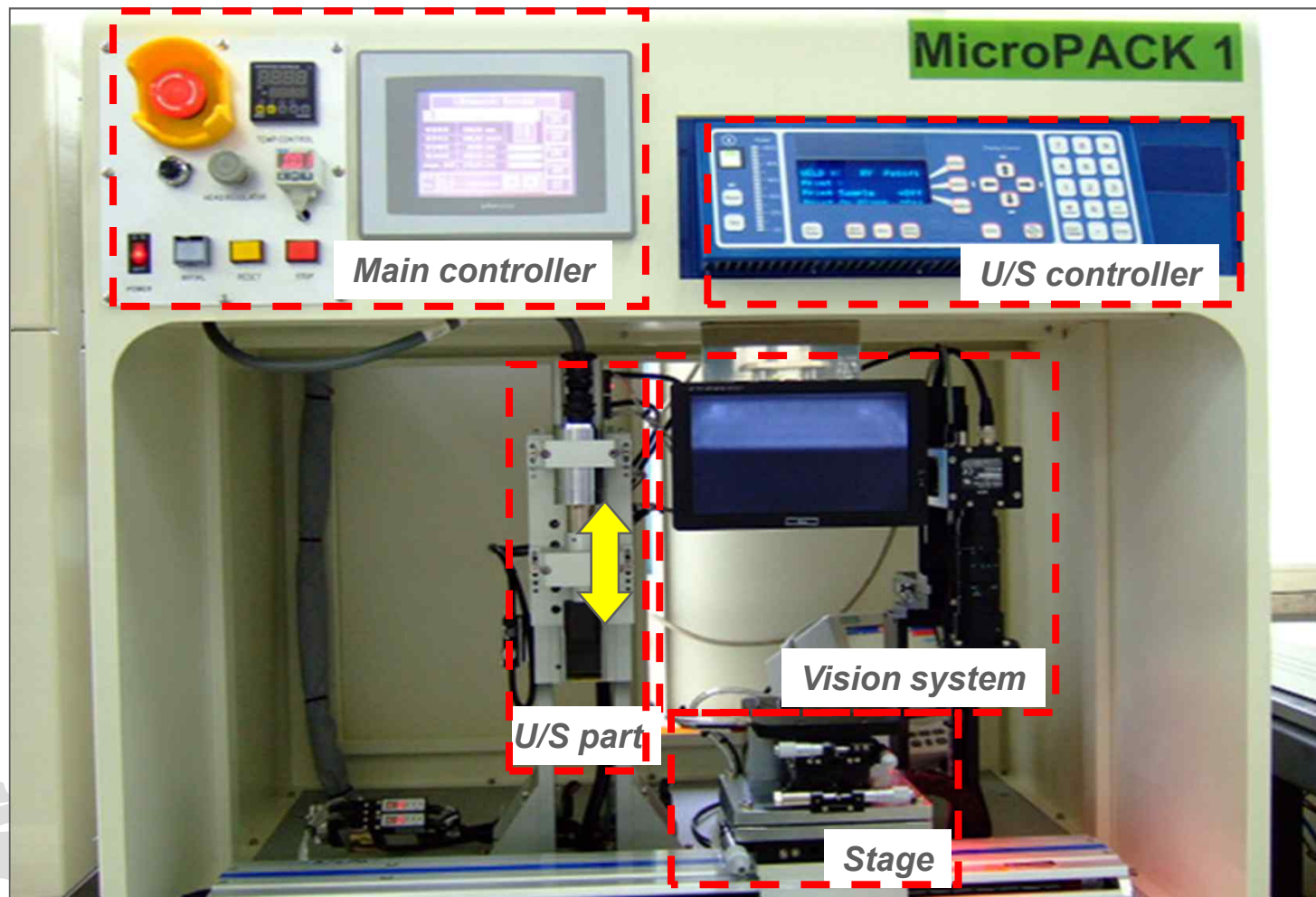


U/S horn (**R.T.**)
→ ACF temperature(> **250 °C**)

- Fast (1/2 ~ 1/3 bonding times)
- No thermal damages
- Energy saving (No heating, 1/10)

The 1st Commercial U/S ACF bonding machine

MPB-U110 : 1 head, 1 stage, manual alignment



Advantages of U/S vs. T/C ACF bonding

1. Reduced Assembly Times & Cost

- Faster ACFs bonding times of U/S method
 - Epoxy ACFs: 3 ~ 5 sec. vs. 7 ~ 15 sec.
 - Acrylic ACFs: 1 ~ 3 sec vs. 5 ~ 7 sec.

2. No thermal damage on boards

- T/C bonding induces thermal damages to boards
- No thermal damages by U/S
 - No bonding tool heating
- Very effective on FOB (organic PCBs) such as **PET or PC based Touch Screen Panel (TSP)** and flexible display (polymer OLED) assembly

3. Eco-Processing

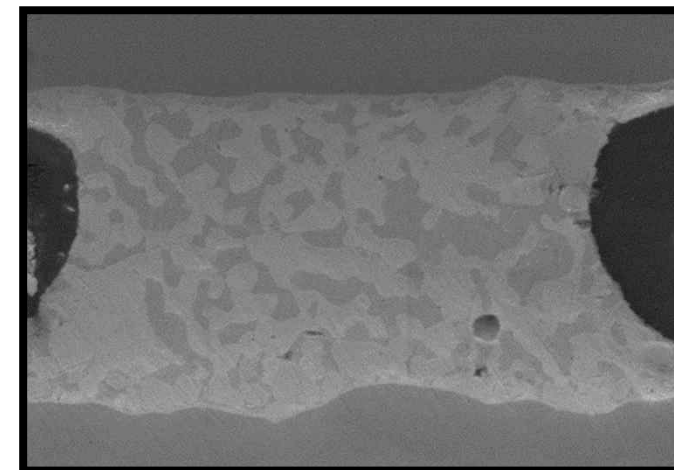
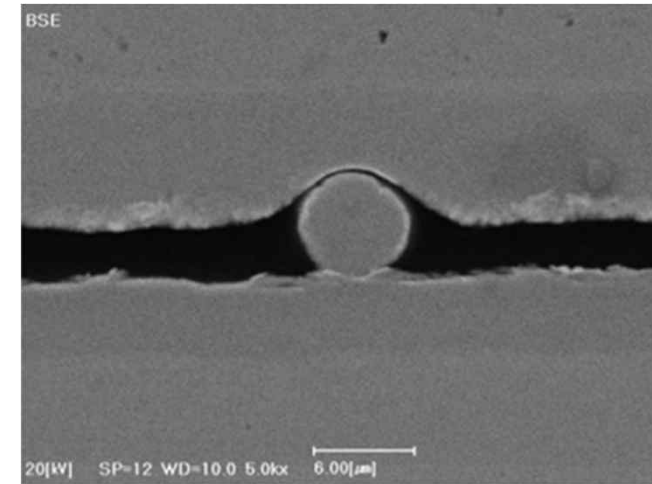
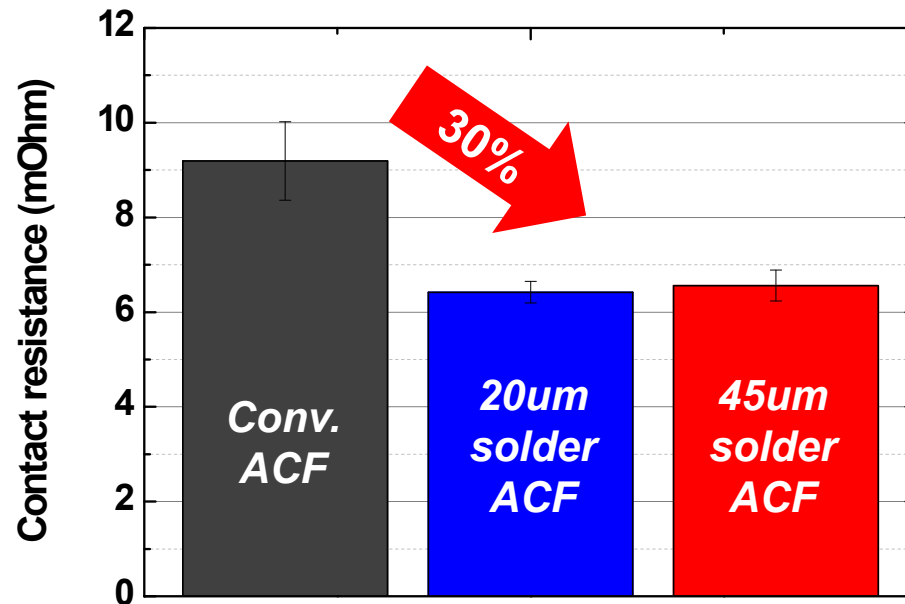
- Significant energy saving
 - Very little U/S loading cycle
 - No idling energy loss – digital control

Solder ACF joints - Contact resistance

Conventional T/C : 160 °C 2MPa 6 sec

U/S : 225 °C 2MPa 5 sec

Contact resistances

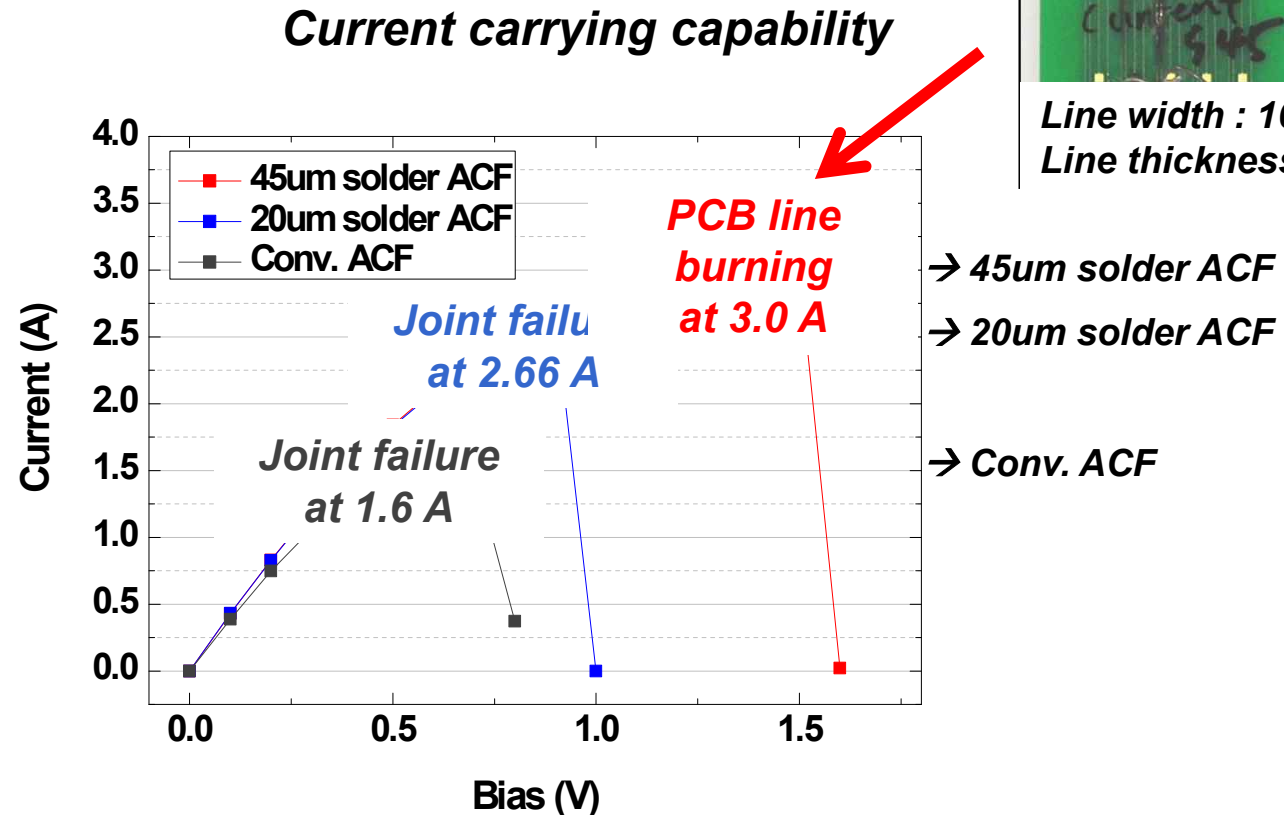


- The solder ACF joints showed **30% lower contact resistances** than that of the conv. Ni ACF joints due to **solder alloy bonding** of solder particles.

Conventional T/C : 160 °C 2MPa 6 sec

U/S : 225 °C 2MPa 5 sec

Solder ACF joints - Current carrying capability



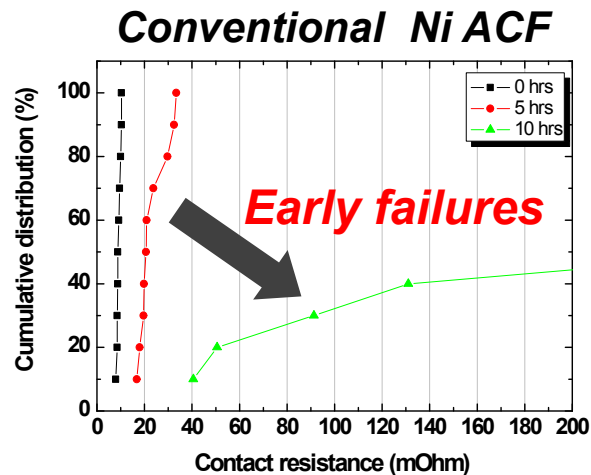
- **The PCB line burns before ACF joint failure.**
- **At least 4X increase of power handling capability (1 Watt → 4 Watt)**

Solder ACF joints - Reliability

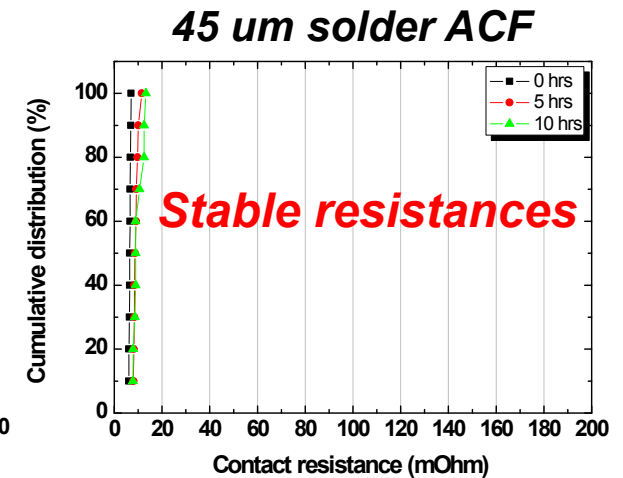
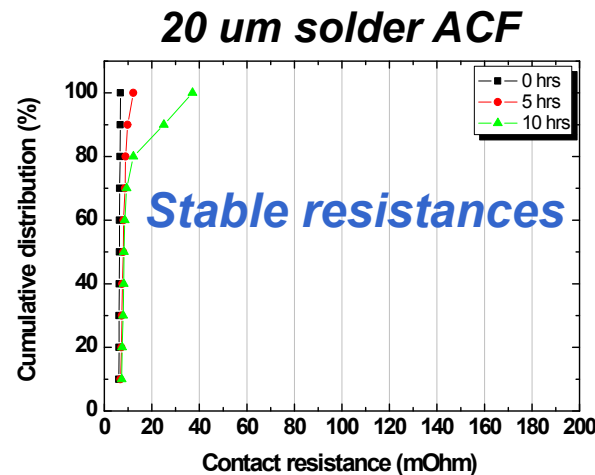
Conventional T/C : 160 °C 2MPa 6 sec

U/S : 225 °C 2MPa 5 sec

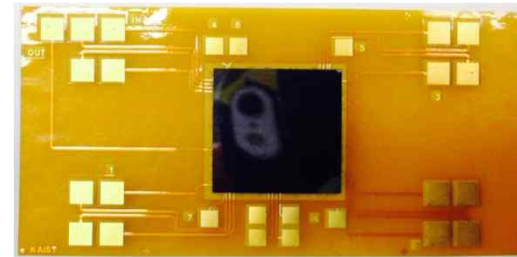
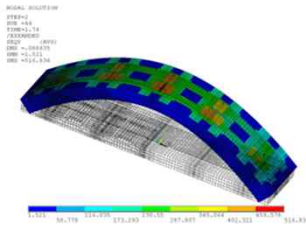
Unbiased autoclave test results (121 °C, 2 atm, 100%RH, 48 hrs)



Rapid degradation of physical point contacts



Summary



For flexible packaging & interconnect for wearable electronics applications,

- 1. **ACF COF & CIF packages** provide excellent **chip flexibility** by **optimizing PKG structure design and ACF materials and processing.***
- 2. And **ACF FOB & FOF & Fabric assembly** using **solder ACFs** combined with **Ultrasonic bonding** offer **30 lower joint resistance, >4X power handling capability, high reliability, and great flexibility** for **wearable electronics** applications!*